



FEL13

SPring-8 Angstrom Compact free-electron LASer

Beamline Instrumentation for Precise Characterization of X-ray FELs

Makina YABASHI

RIKEN SPring-8 Center (RSC), Beamline R&D Group

yabashi@spring8.or.jp

August 27, 2013 @New York

Contents

1. Introduction
 - Importance of x-ray diagnostics
2. Photon diagnostics (I): pulse energy & transverse phase space
3. Photon diagnostics (II): Longitudinal phase space
4. Summary

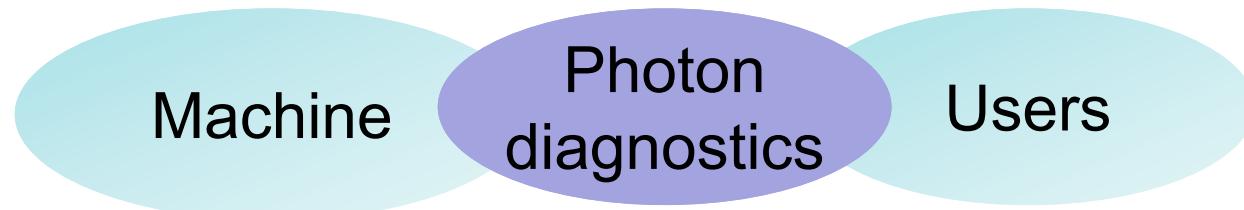
Why are photon diagnostics important for XFEL facilities ?

- Photon beam is a final product of XFEL source to **user experiments**

- e.g. studies on X-ray nonlinear interactions

$$\text{Peak Power } (W/cm^2) \sim \frac{\text{Pulse energy}}{(\text{Pulse duration})(\text{Beam size})}$$

- Photon beam contains a number of key information for **machine operation**
 - could be more accurate and robust than electrons
- Photon diagnostics become **strong linkage between machine and users**



Objective

1. X-ray beam profiles in 6-D phase space

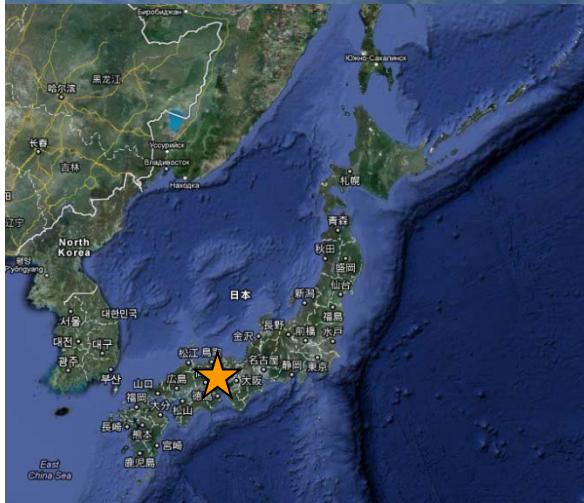
- Total photon number (pulse energy)
- Spatial profile, centroid
- Wavefront/Angular divergence
- Spectrum
- Temporal profile
- Arrival timing to external laser
- Polarization

2. Key

- Shot-to-shot (non-average)
- Nondestructive (for users)
- Wide dynamic range (spontaneous to fully saturated x-rays)

Introduce experiences at SACLÀ

SACLA @SPring-8

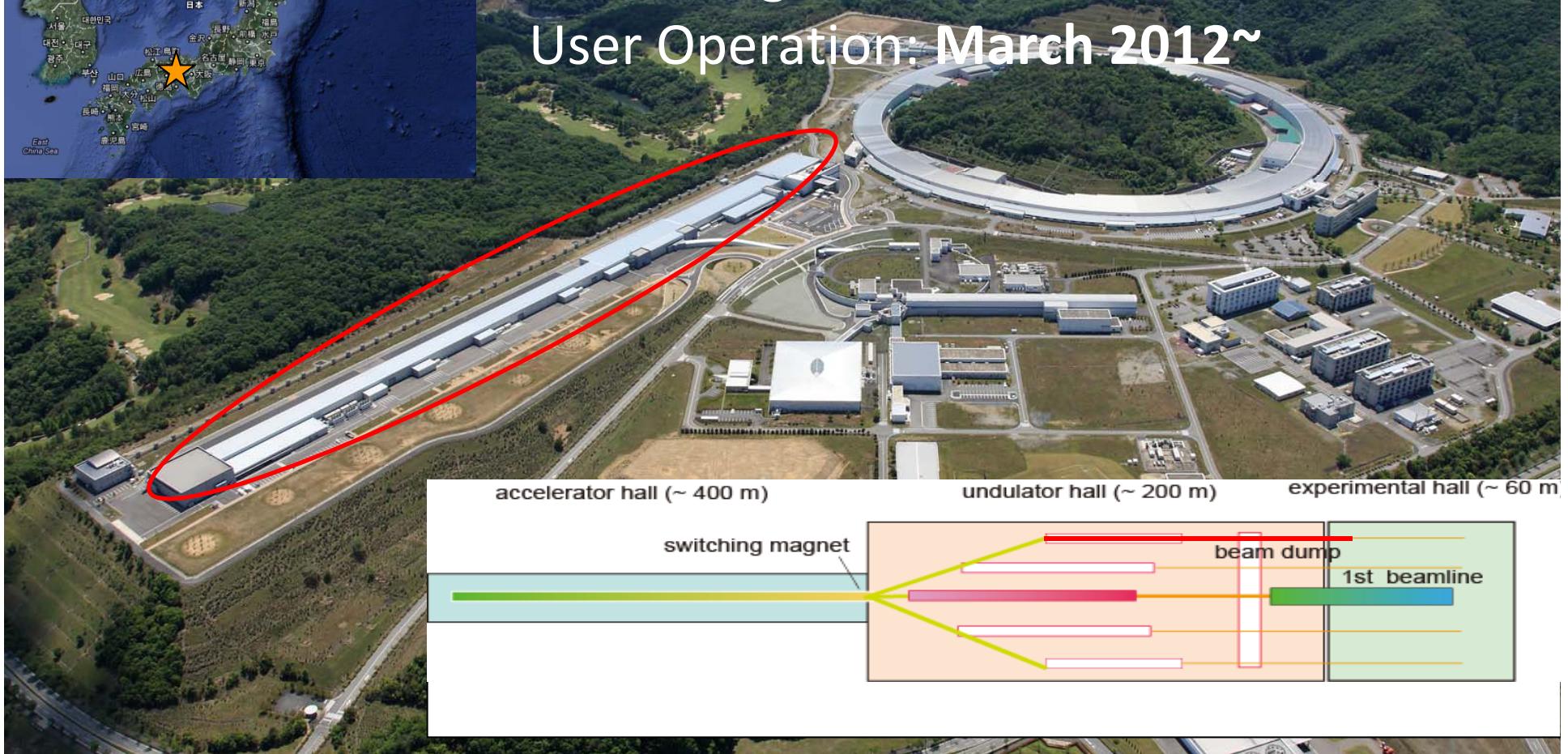


Compact XFEL

Construction: FY2006~2010

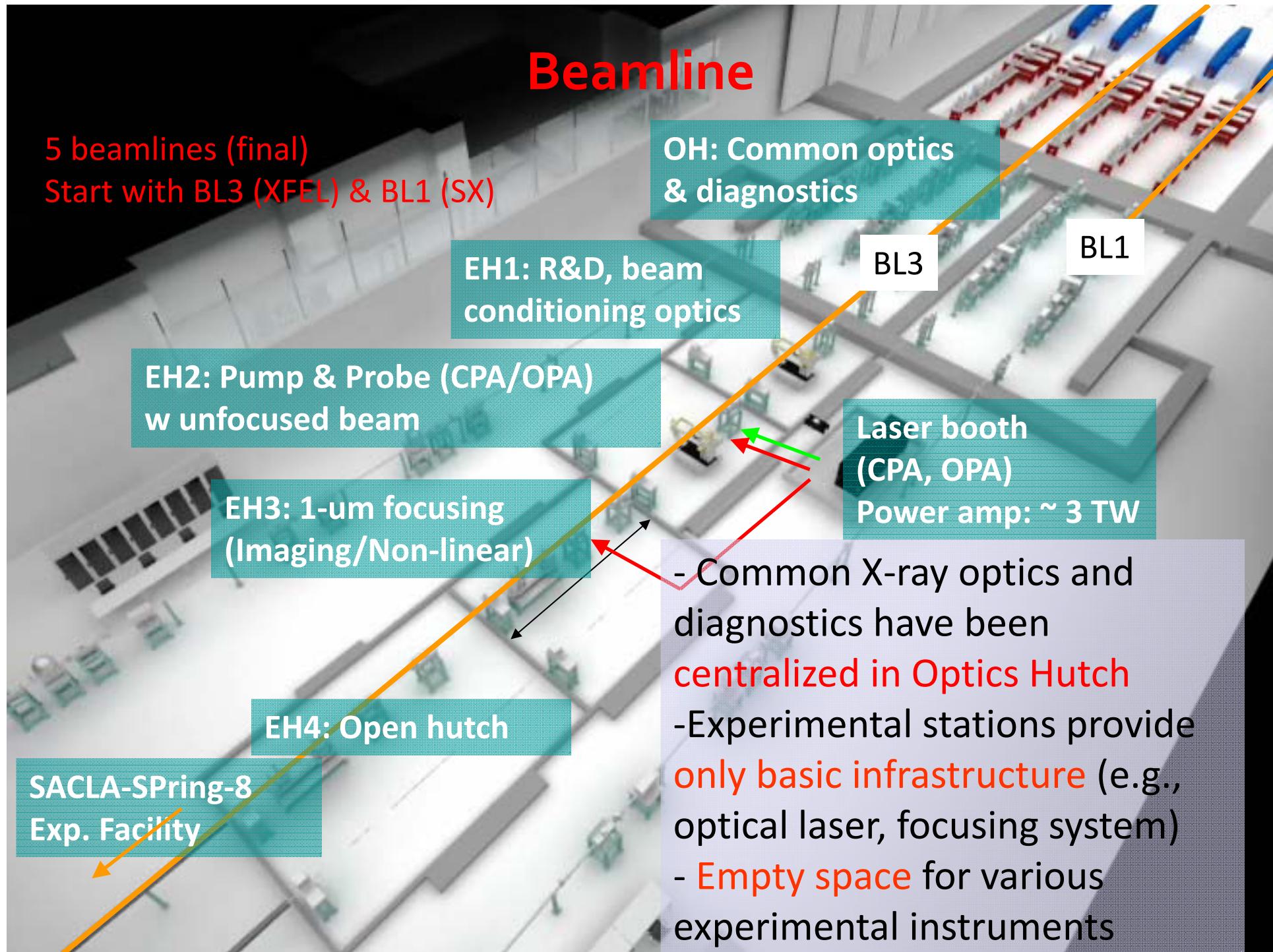
First lasing: June 2011

User Operation: March 2012~

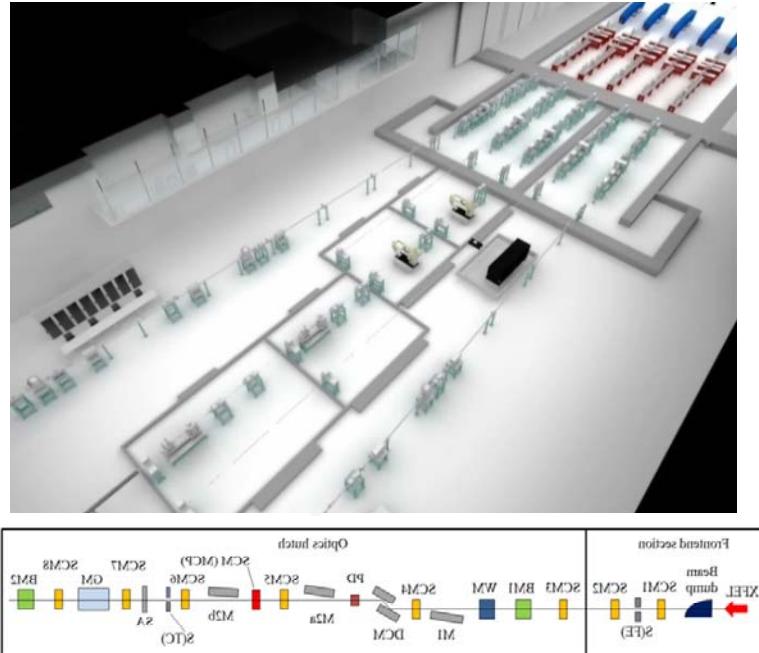


Experimental Building

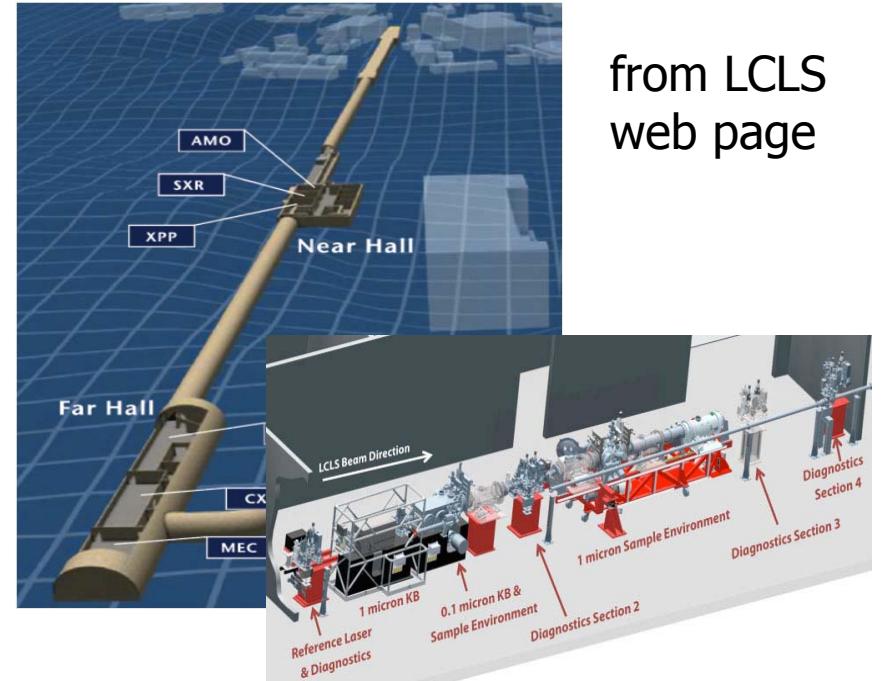




Comparison of BL design concept: SACLA vs. LCLS

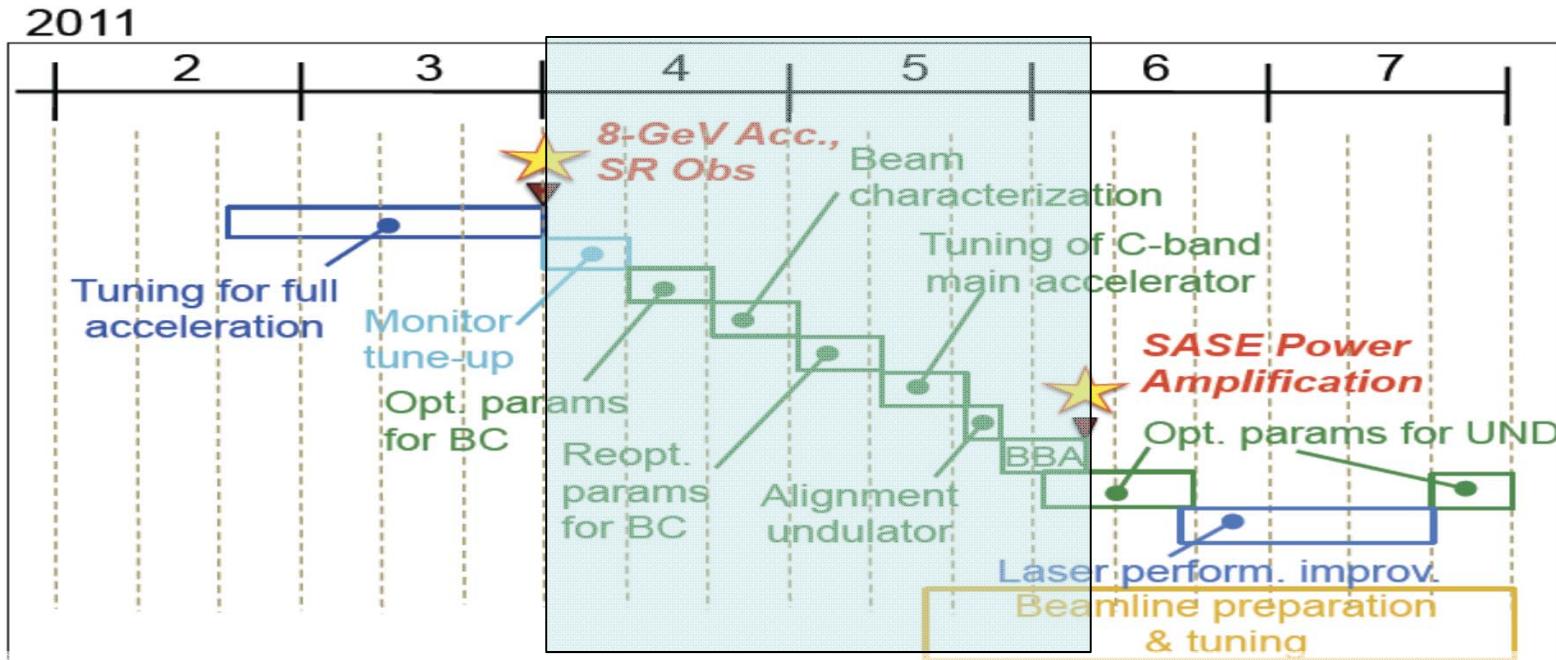


- Brand-new machine with unknown electron-beam properties
 - Mitigate risks by introducing photon diagnostics
 - Utilize X-ray diagnostics in optics hutch for **both machine and users**



- Machine can operate with matured e-diagnostics
 - X-ray optics & diagnostics are located in every experimental hutch **(only for users)**

Example: Commissioning of SACLA



X-ray beamline (optics and photon diagnostics) played a key role for enabling quick lasing in two months

**nature
photronics** LETTERS

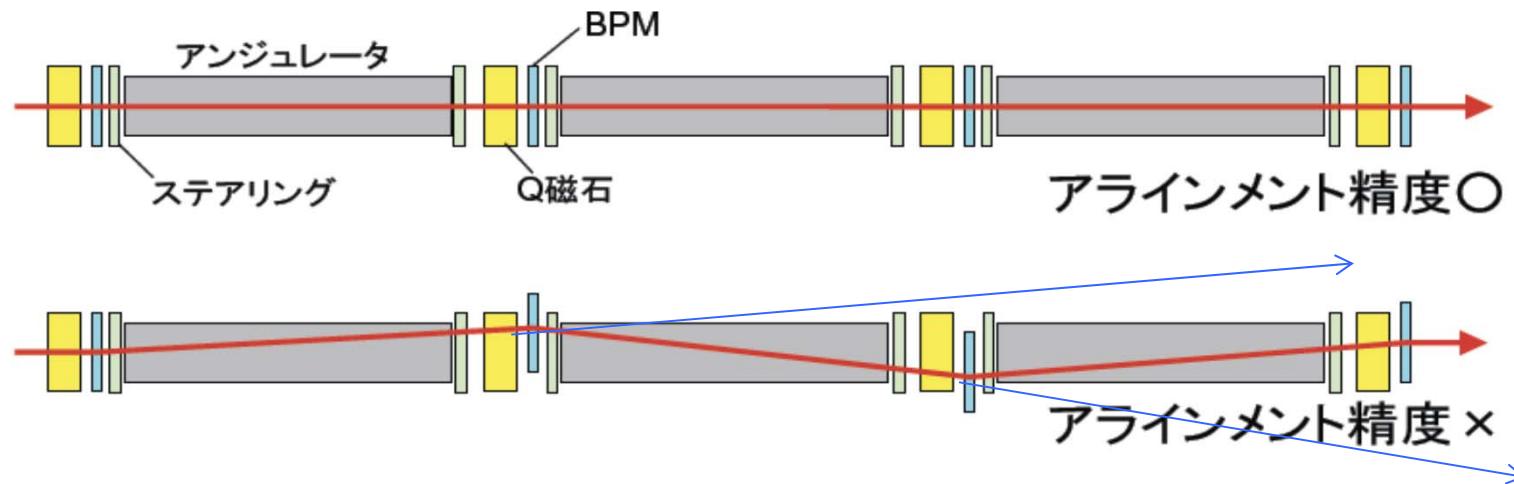
PUBLISHED ONLINE: 24 JUNE 2012 | DOI: 10.1038/NPHOTON.2012.141

A compact X-ray free-electron laser emitting in the sub- \AA ngström region

Nat. Photon 6, 540 (2012)

Hitoshi Tanaka and Makina Yabashi et al.*

Precise ID tuning using beamline optics/diagnostics

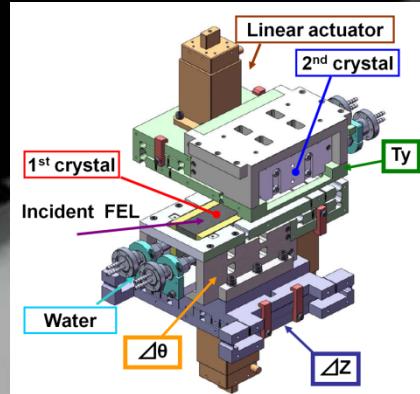


- Overlap between e- and p-beam with an accuracy of \sim urad is required
- E-beam trajectory easily bends at the edges of undulator modules
- P-beam goes through along the e-beam in the undulator
- P-beam can be used to monitor the e-beam trajectory in each undulator module

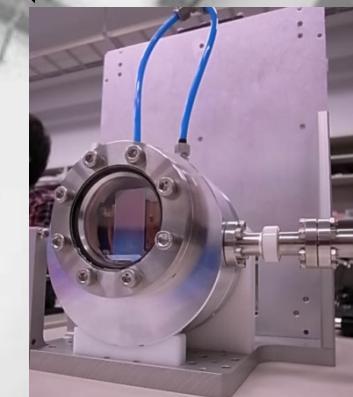
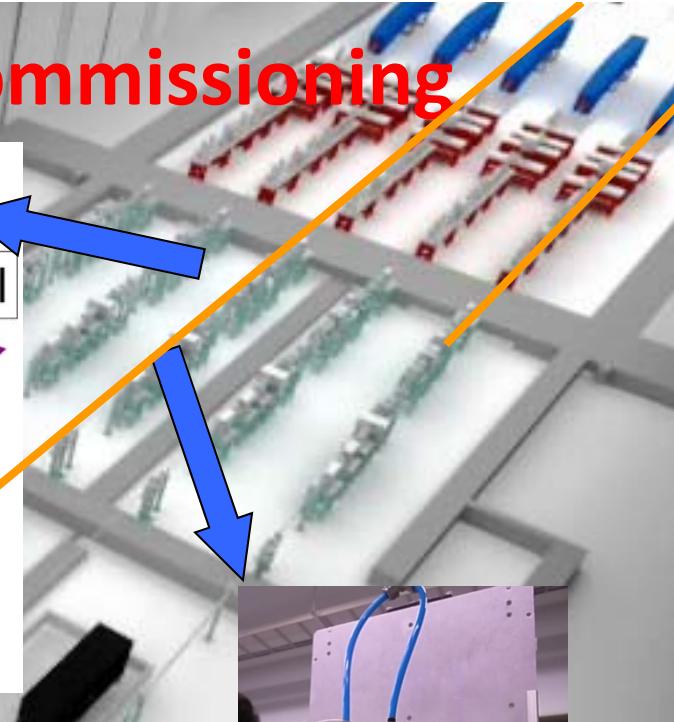
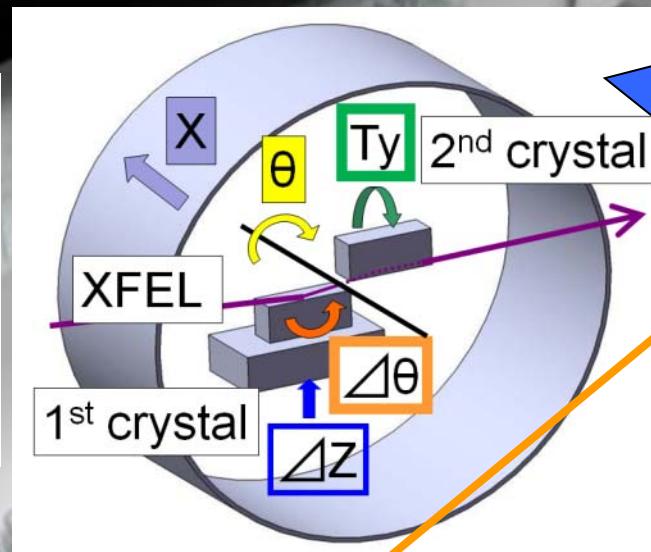
Cf. central cone of the undulator radiation

$$1/g = 1/16000 = 60 \text{ urad} \text{ for } 8 \text{ GeV}$$

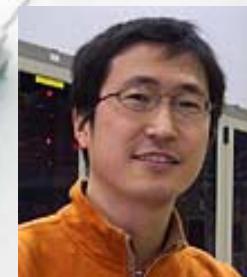
Key components for SACLÀ commissioning



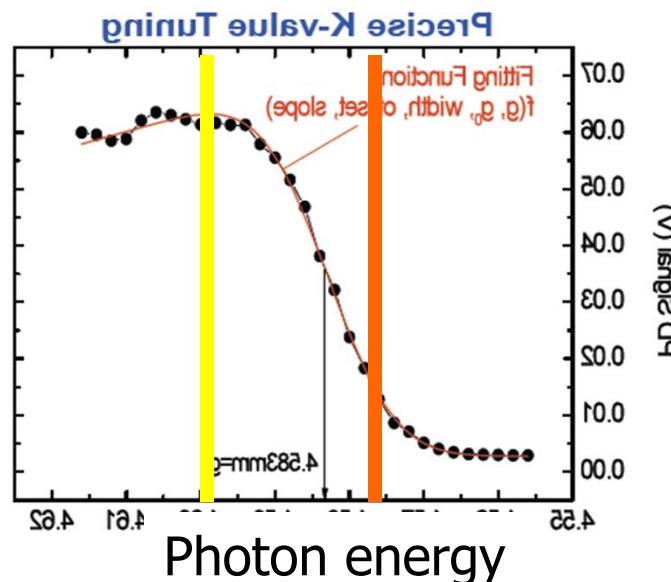
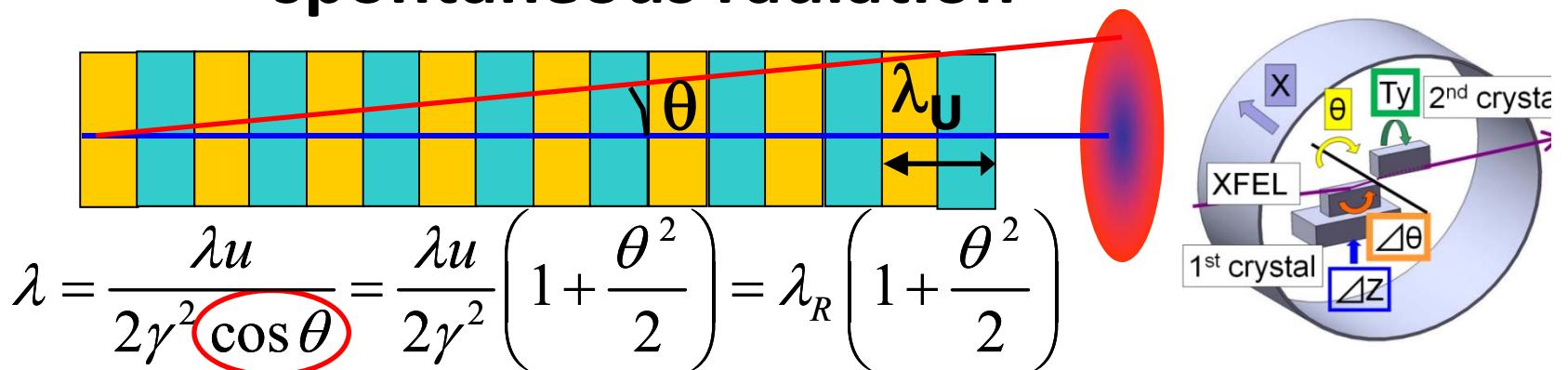
DCM Si(111)
High stability;
UHV compatible
(Ohashi et al.)



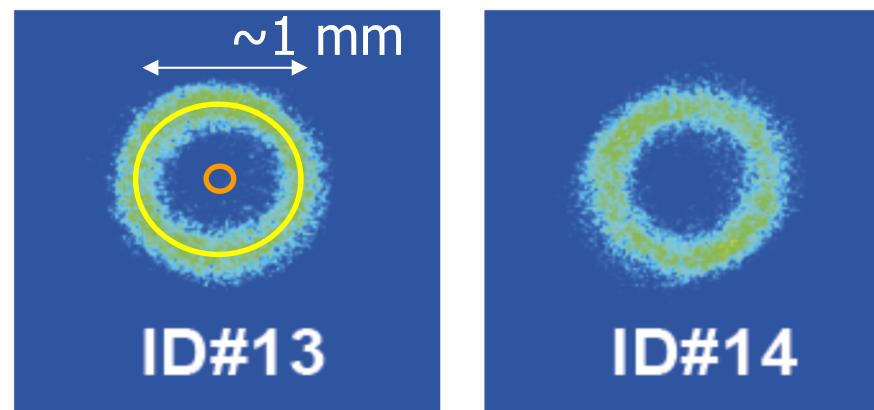
single-sensor
MPCCD
(Hatsui et al)



Spatial profile of monochromatic spontaneous radiation



profile of monochromatic spontaneous rad



PHYSICAL REVIEW SPECIAL TOPICS - ACCELERATORS AND BEAMS 15, 110701 (2012)

Undulator commissioning by characterization of radiation in x-ray free electron lasers

Takashi Tanaka,* Shunji Goto, Toru Hara, Takaki Hatsui, Haruhiko Ohashi, Kazuaki Togawa, Makina Yabashi, and Hitoshi Tanaka

T. Takashi et al
PRST 12

SACLA: Summary of Performance

Pulse Energy	0.4 mJ @10 keV
Photon energy range	4.5 to 15 keV
Stability Intensity $\sigma_{\delta I/I}$	$\leq 10\%$
Pointing	3 ~7% of beam size
Repetition rate	20 Hz (Max. 60 Hz)

Contents

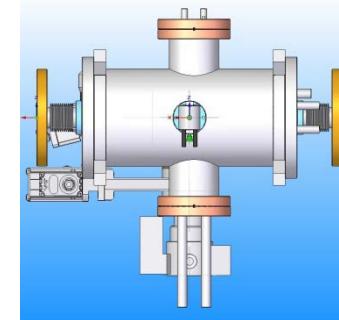
1. Introduction
2. Photon diagnostics (I): pulse energy & transverse phase space
3. Photon diagnostics (II): longitudinal phase space
4. Summary

Pulse energy measurement

Pulse-to-pulse, wide dynamic range w/o saturation

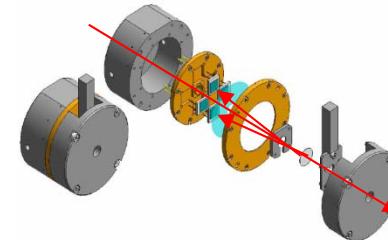
Ion chamber using gas ionization

- semi-transparent in wide wavelength range
- absolute measurement
- △ need care to nonlinearity
- △ need cost space for vacuum system



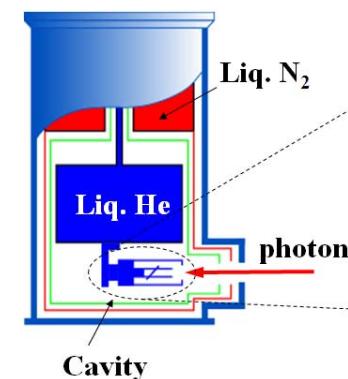
Foil-based backscattering monitor

- semi-transparent above a few keV
- △ need care to damage to foil

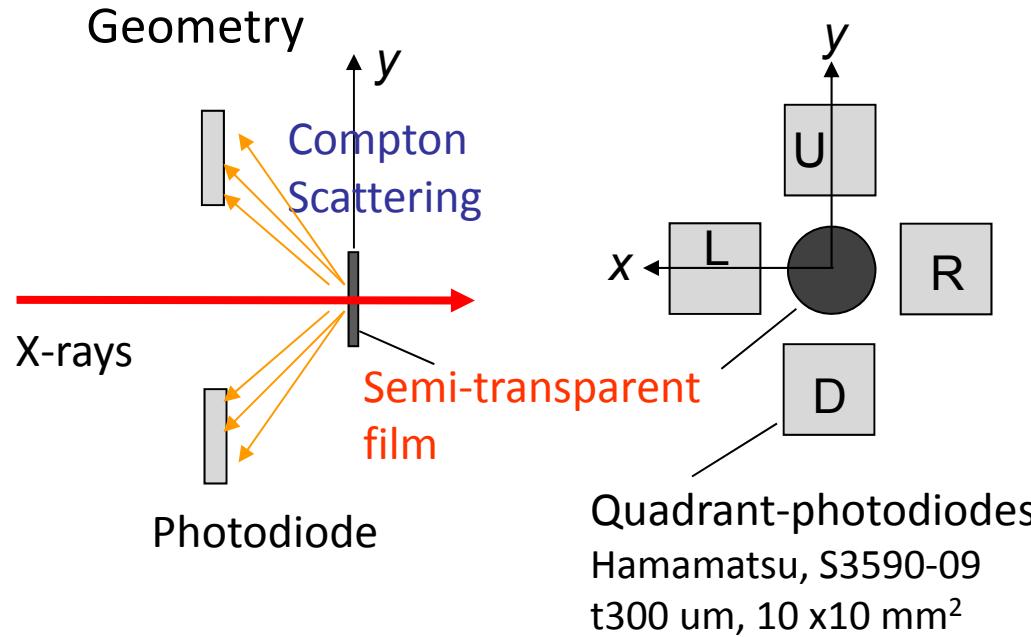


Calorimeter

- absolute measurement
- △ destructive
- △ average measurement



Pulse energy diagnostics: Thin-foil backscattering monitor



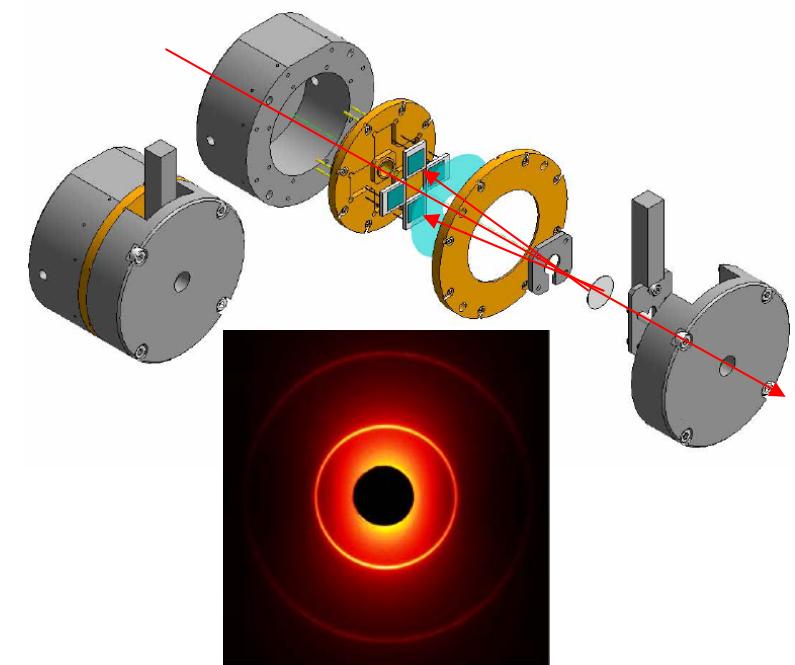
Intensity $I = I_L + I_R + I_U + I_D$

Position $x = K_x \frac{I_L - I_R}{I_L + I_R} = K_x \Delta I_x$

$$y = K_y \frac{I_U - I_D}{I_U + I_D} = K_y \Delta I_y$$

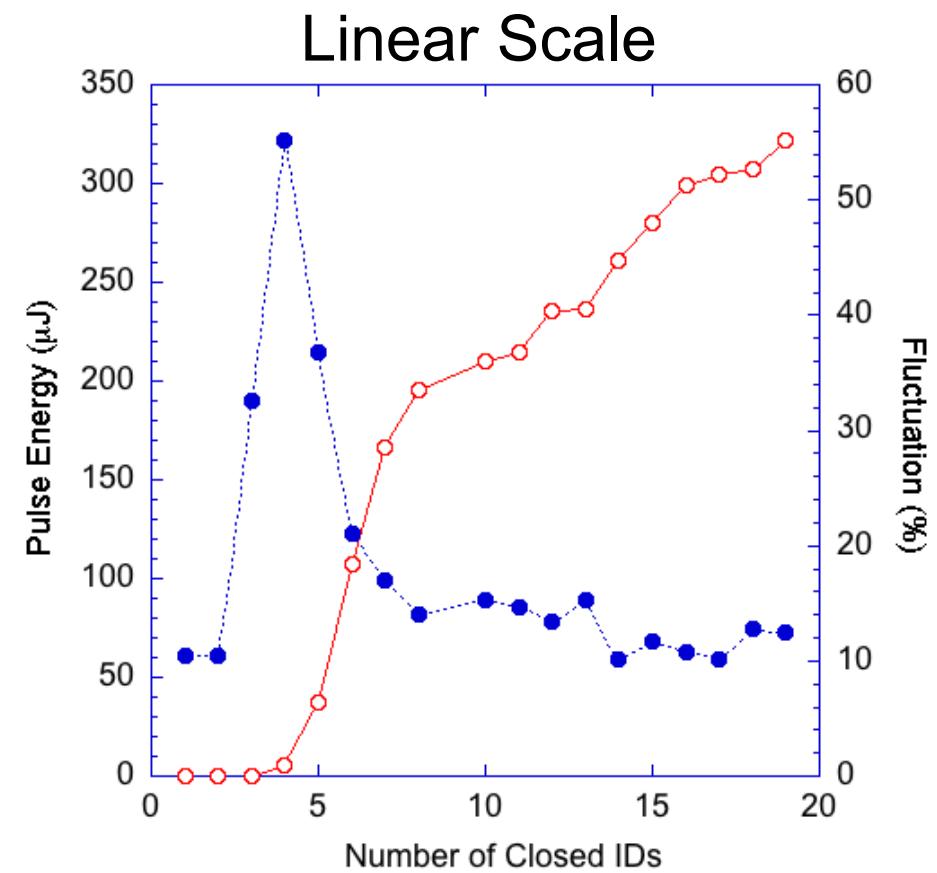
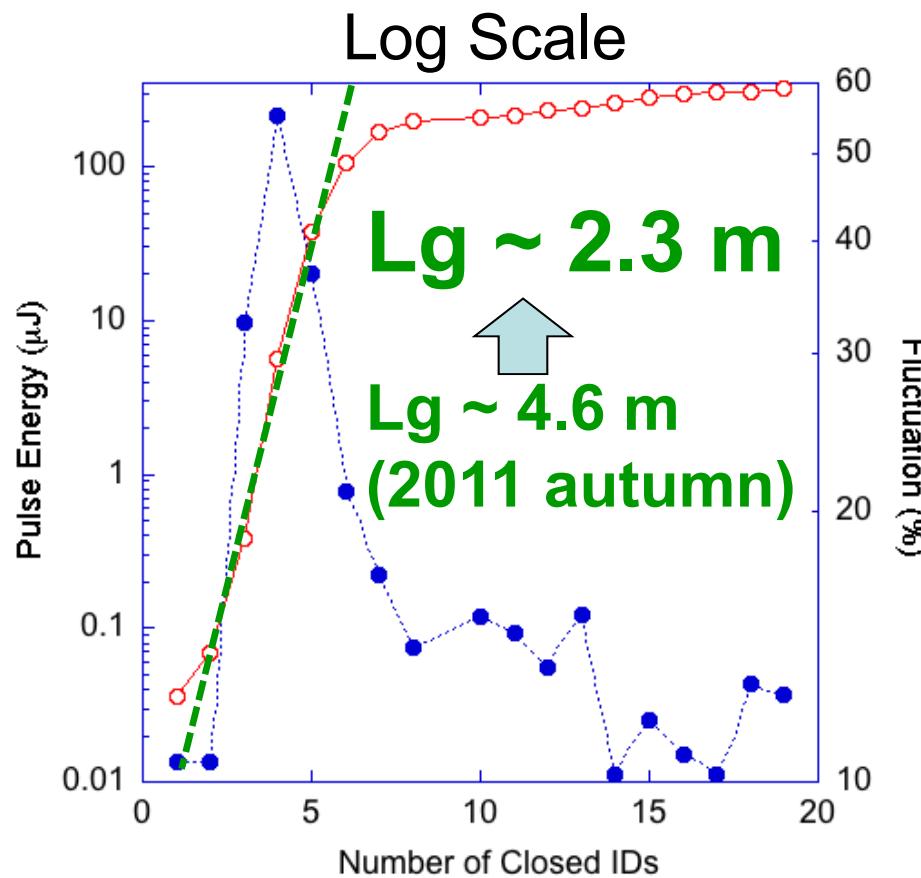
Tono et al., RSI 82, 023108 (2011)

Collaboration with LCLS



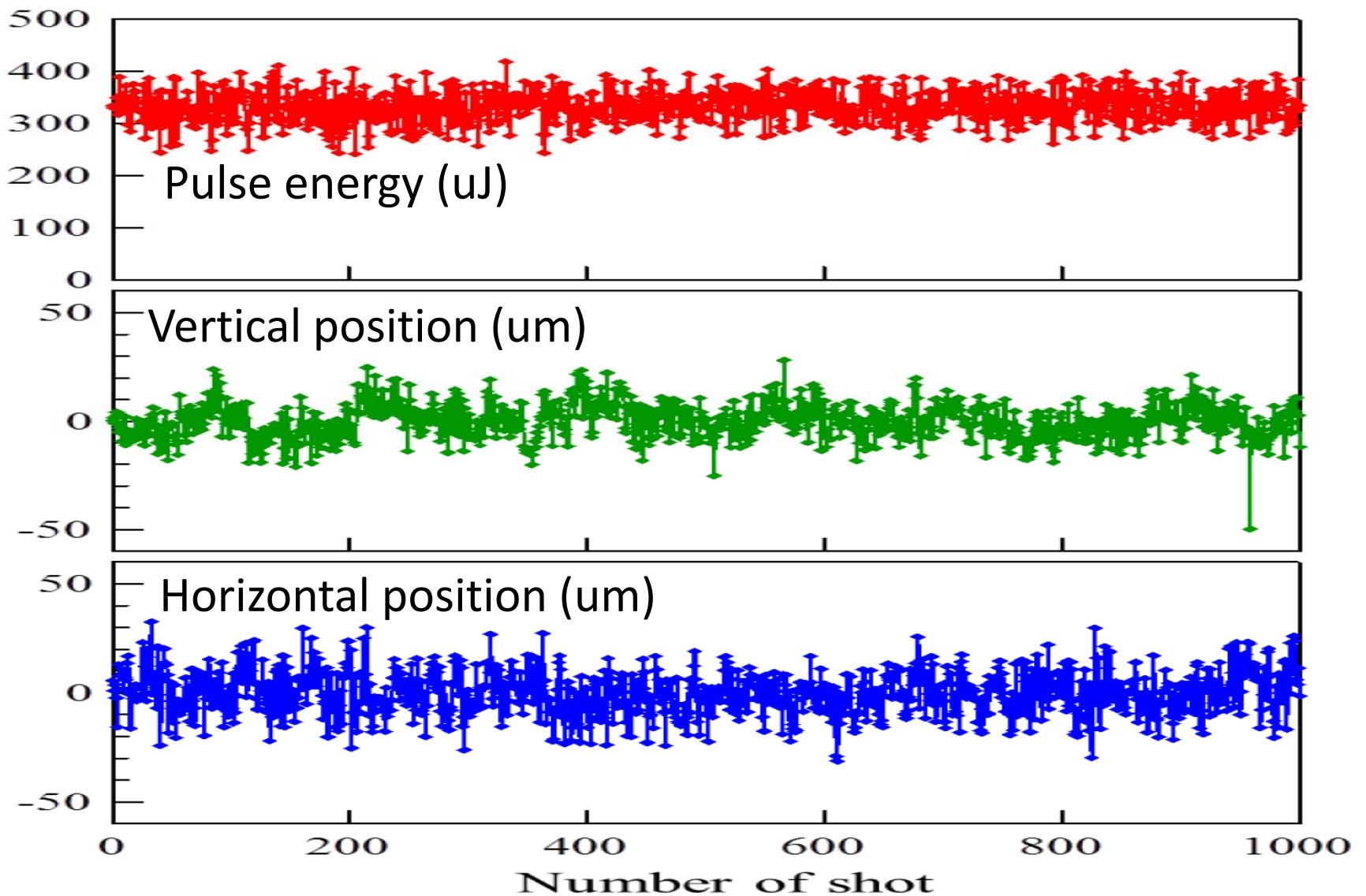
CVD- "nano" Diamond
Smooth Debye-Scherrer ring
Speckle-free
Semi-transparent (>97%@10 keV)
Wide d-range (10 nJ ~ 10 mJ)

Application (1): Gain curve measurement



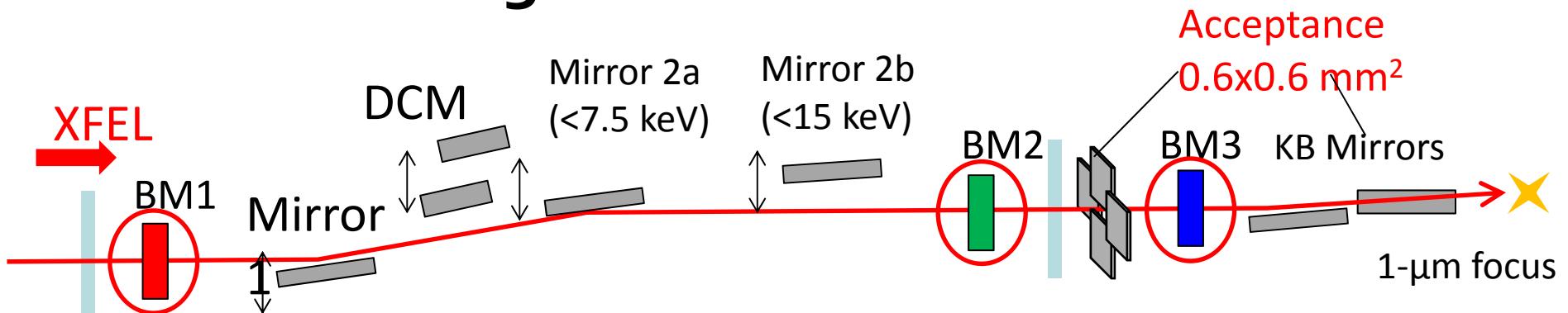
Application (2)

Routine monitoring at control room



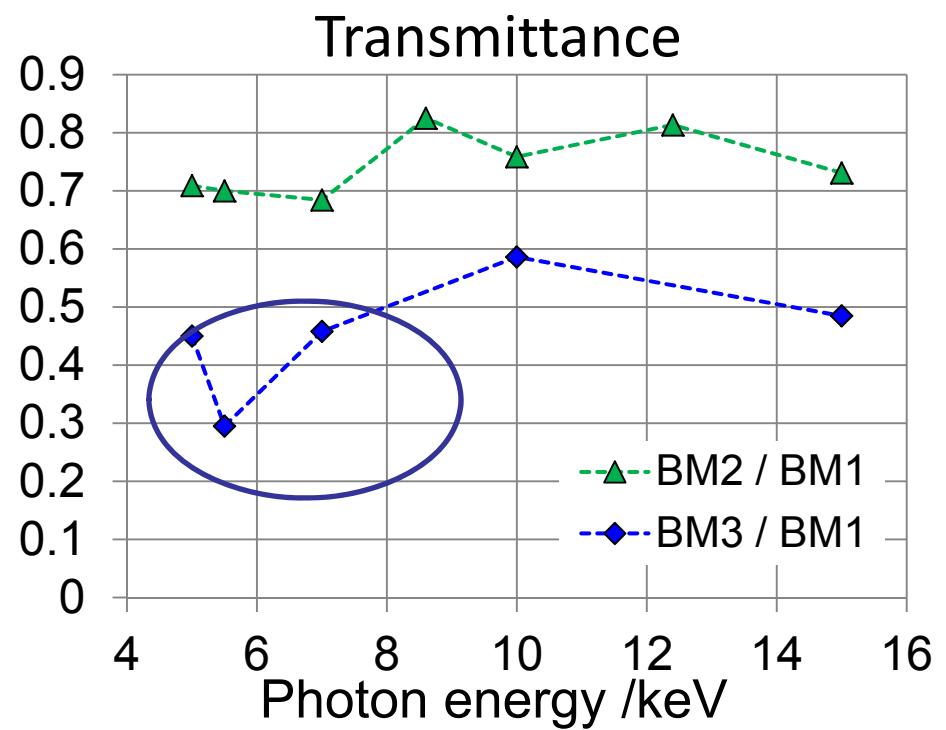
Application (III)

Monitoring of Beamline Transmittance



Mismatch between beam size
and mirror acceptance

Increase of mirror acceptance

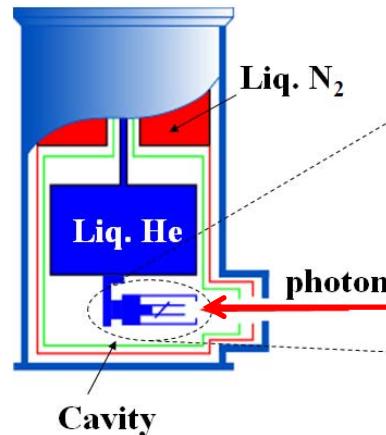


“From Relative to Absolute”

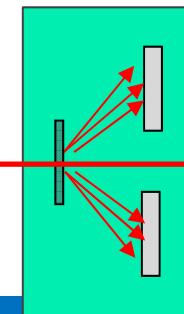
International Collaboration

Calorimeter
(AIST)

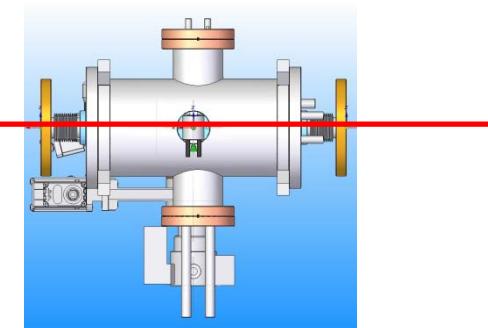
RT-type:
Worked!



Thin-foil monitor
(SACLA)

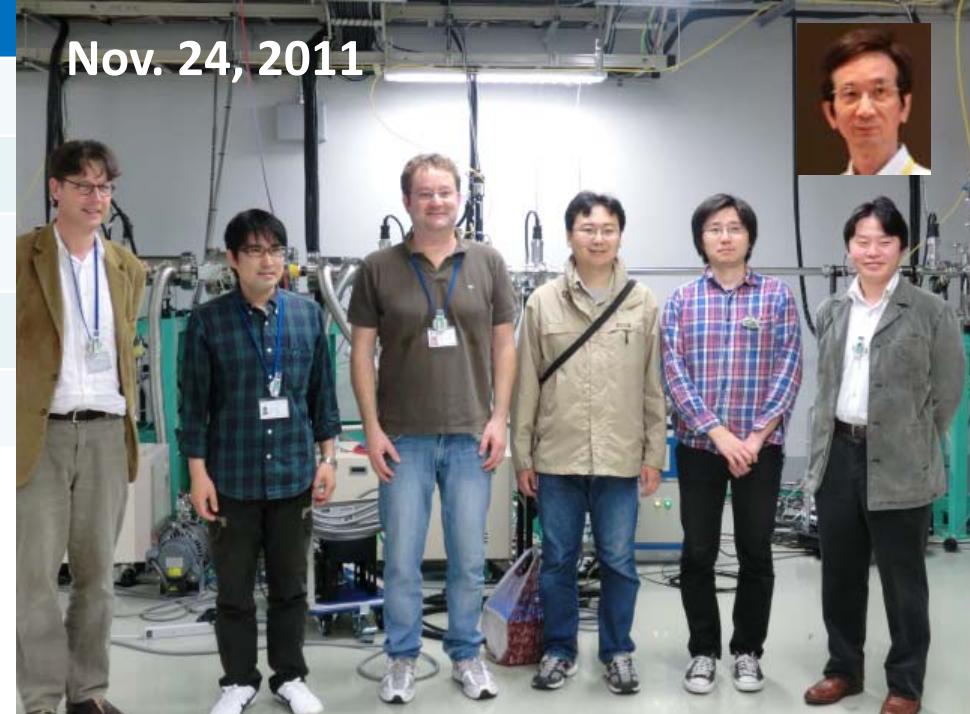


Gas monitor detector
(DESY/PTB)



Photon energy /keV	Pulse energy / μ J	
	Radiometer	XGMD
4.4	32.26 ± 0.35	32.9 ± 2.0
5.8	104.2 ± 1.3	106.6 ± 6.1
9.6	95.3 ± 2.3	93.9 ± 6.1
13.6	42.2 ± 1.1	40.8 ± 2.9
16.8	0.96 ± 0.03 Max. Deviation = 3.3%	---

Nov. 24, 2011



T. Tanaka et al., NIMA 659, 528 (2011).
K. Tiedtke et al., JAP. 103, 94511 (2008).

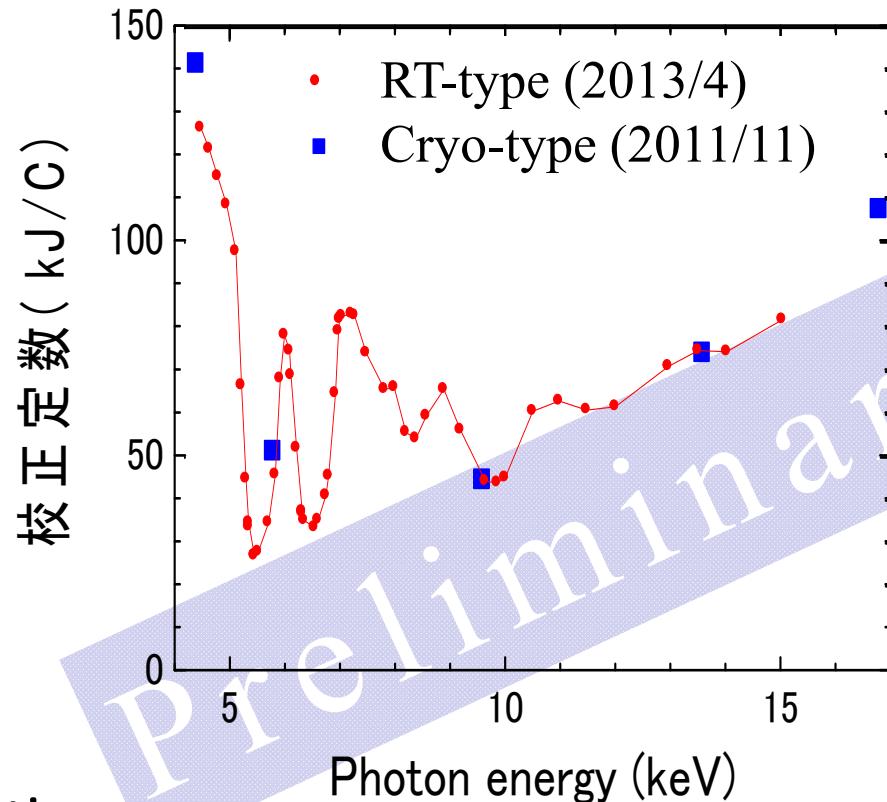
Kato *et al*, Appl. Phys. Lett.
101, 023503 (2012)

New portable calorimeter operating at room temperature

Developed by AIST and RIKEN, tested on April 2013



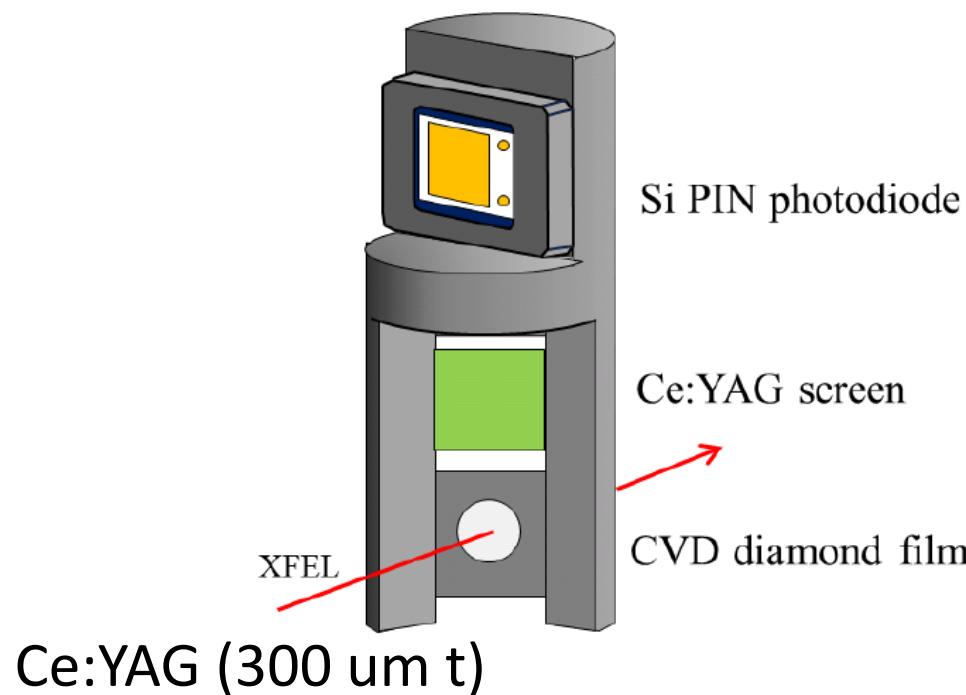
Saito-san
(AIST)



Tanaka, Saito et al, in preparation
Push to commercially available device

Spatial Profile Diagnostics (I)

Retractable screens

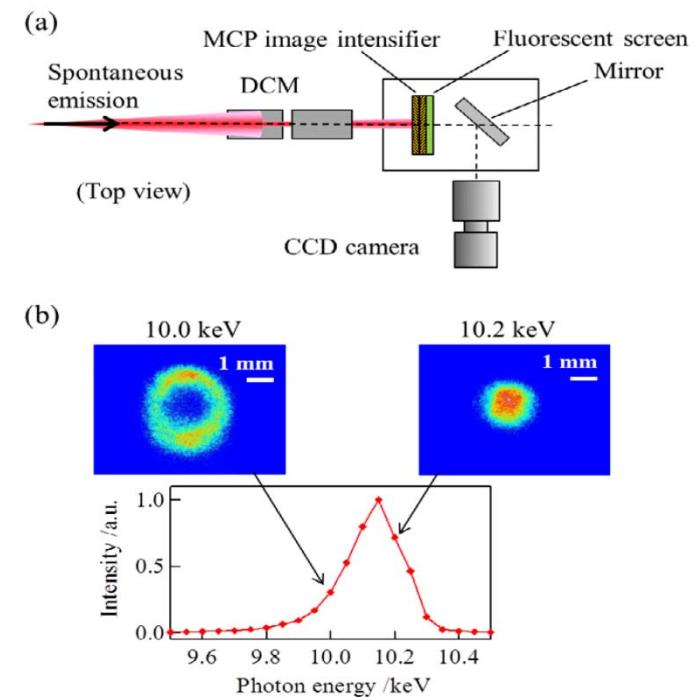


high efficiency ($\sim 1 \text{ uJ/pls}$)
destructive

CVD B-doped diamond (30 um t)
low-efficiency
semi-transparent (>97% for 10-keV)
speckle-free

-> Available as inline, routine monitors

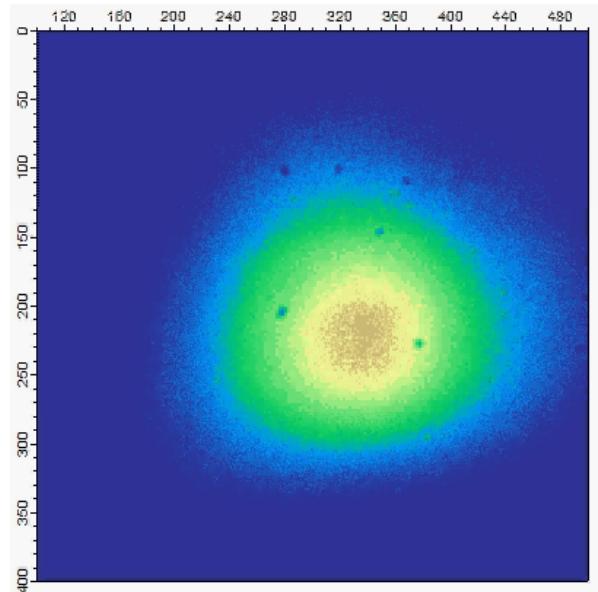
Phosphor-coupled-MCP monitor



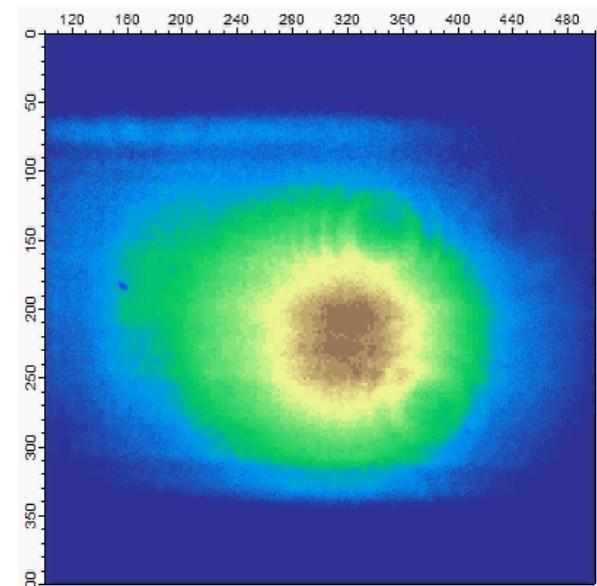
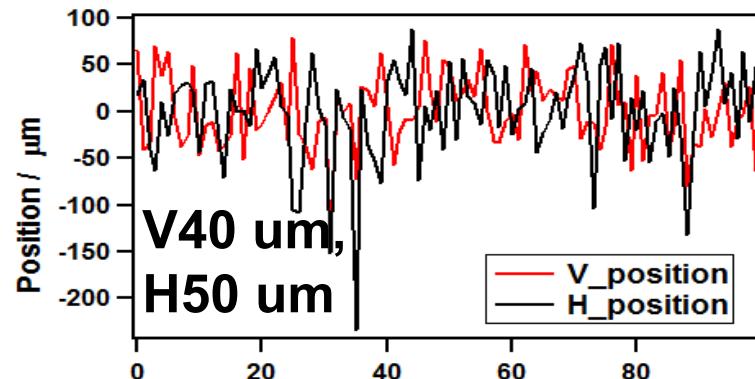
- Very high efficiency to image spontaneous radiation
- Routine use for undulator alignment in every two weeks

Spatial Profile & Pointing Stability

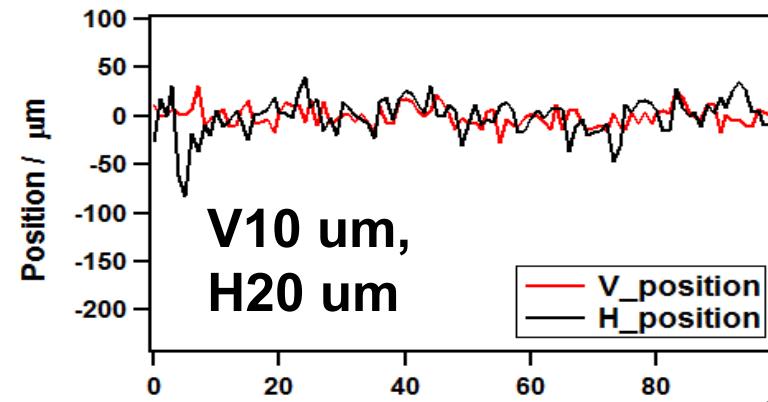
Temperature stabilization of injector section (2012 autumn)



July 25, 2012



Sep. 18, 2012

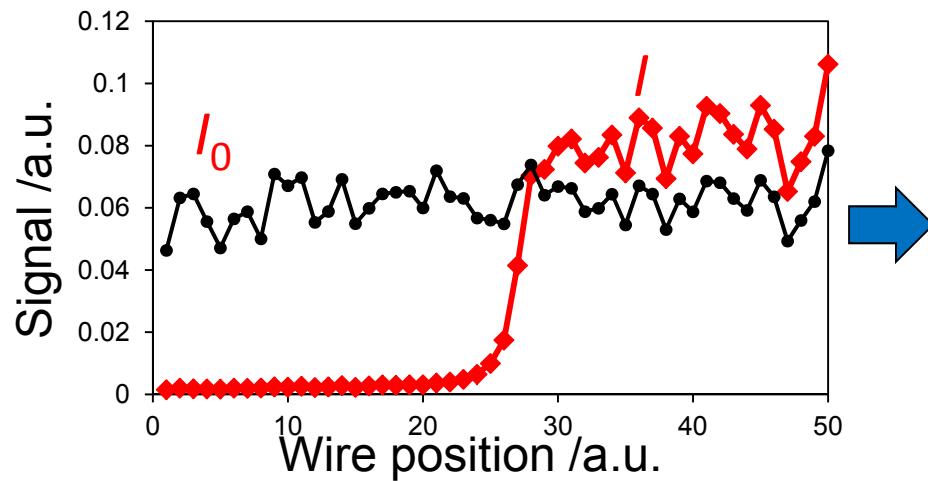


Spatial Profile Diagnostics (II)

Slit/knife-edge scanning method

Stability ? (intensity/position)

1- μm Focusing at EH3



Yumoto et al Nature Photon. 7, 43 (2013)

nature
photronics

LETTERS

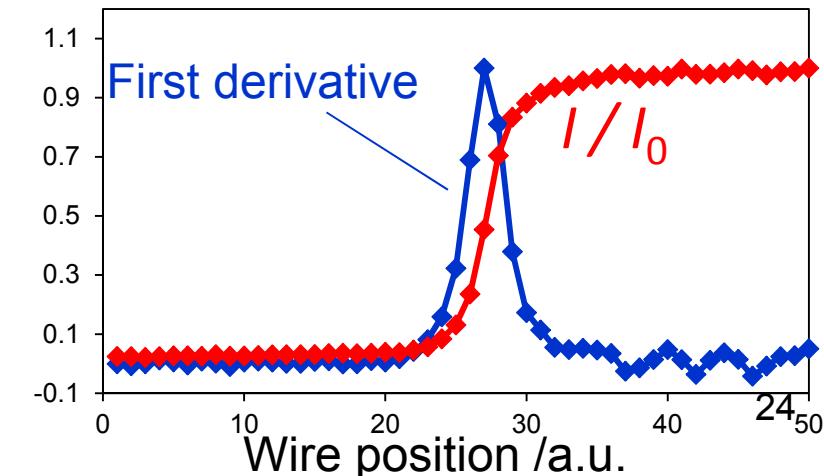
PUBLISHED ONLINE: 16 DECEMBER 2012 | DOI: 10.1038/NPHOTON.2012.306

Focusing of X-ray free-electron laser pulses with reflective optics

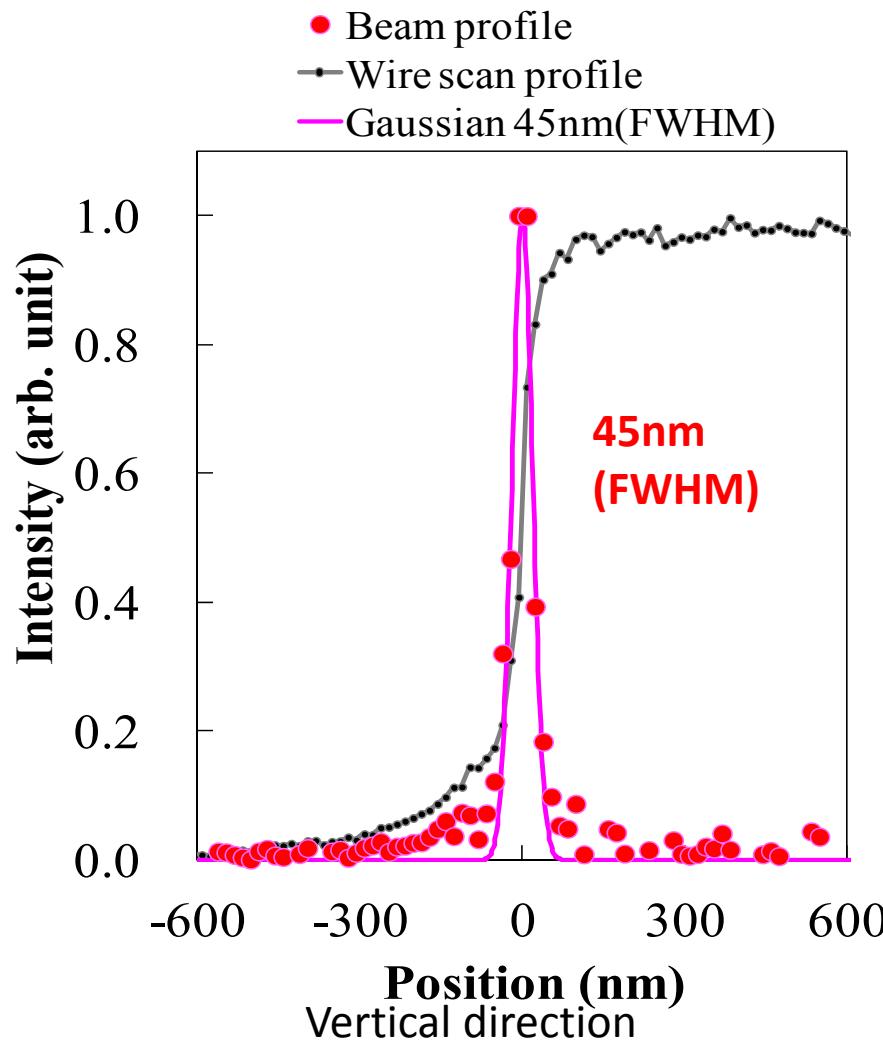
Hirokatsu Yumoto^{1*}, Hidekazu Mimura², Takahisa Koyama¹, Satoshi Matsuyama^{3,4}, Kensuke Tono¹, Tadashi Togashi¹, Yuichi Inubushi⁵, Takahiro Sato⁵, Takashi Tanaka⁵, Takashi Kimura⁶, Hikaru Yokoyama³, Jangwoo Kim³, Yasuhisa Sano³, Yousuke Hachisu⁷, Makina Yabashi⁵, Haruhiro Ohashi^{7,5}, Hitoshi Ohmori⁷, Tetsuya Ishikawa⁵ and Kazuto Yamauchi^{1,3,4,8}

X-ray free-electron lasers^{1,2} produce intense femtosecond pulses that have applications in exploring new frontiers in science. The unique characteristics of X-ray free-electron

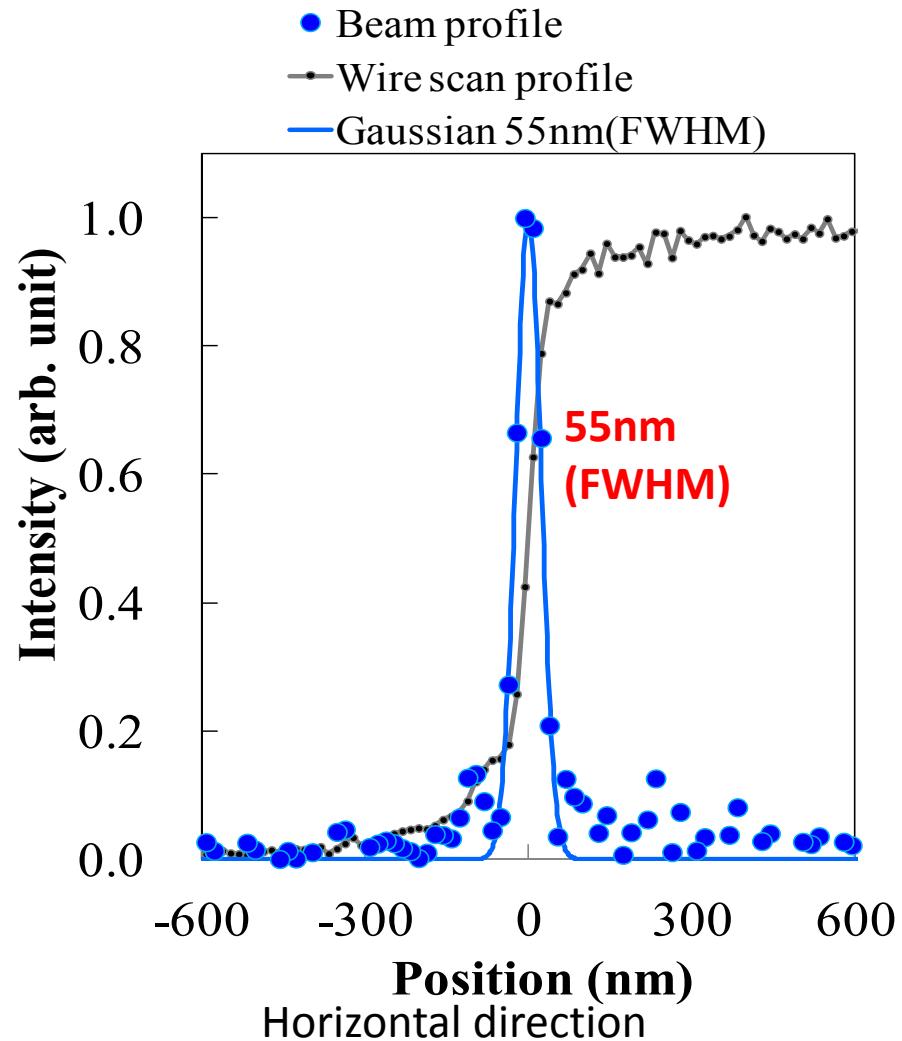
To date, refractive¹⁰, diffractive^{3,11} and reflective optics¹² have been developed to focus X-rays. Of these options, total reflective optics in the Kirkpatrick-Baez (K-B) geometry¹³, which combines



Measurement of nano-scale spot with two-stage focusing system



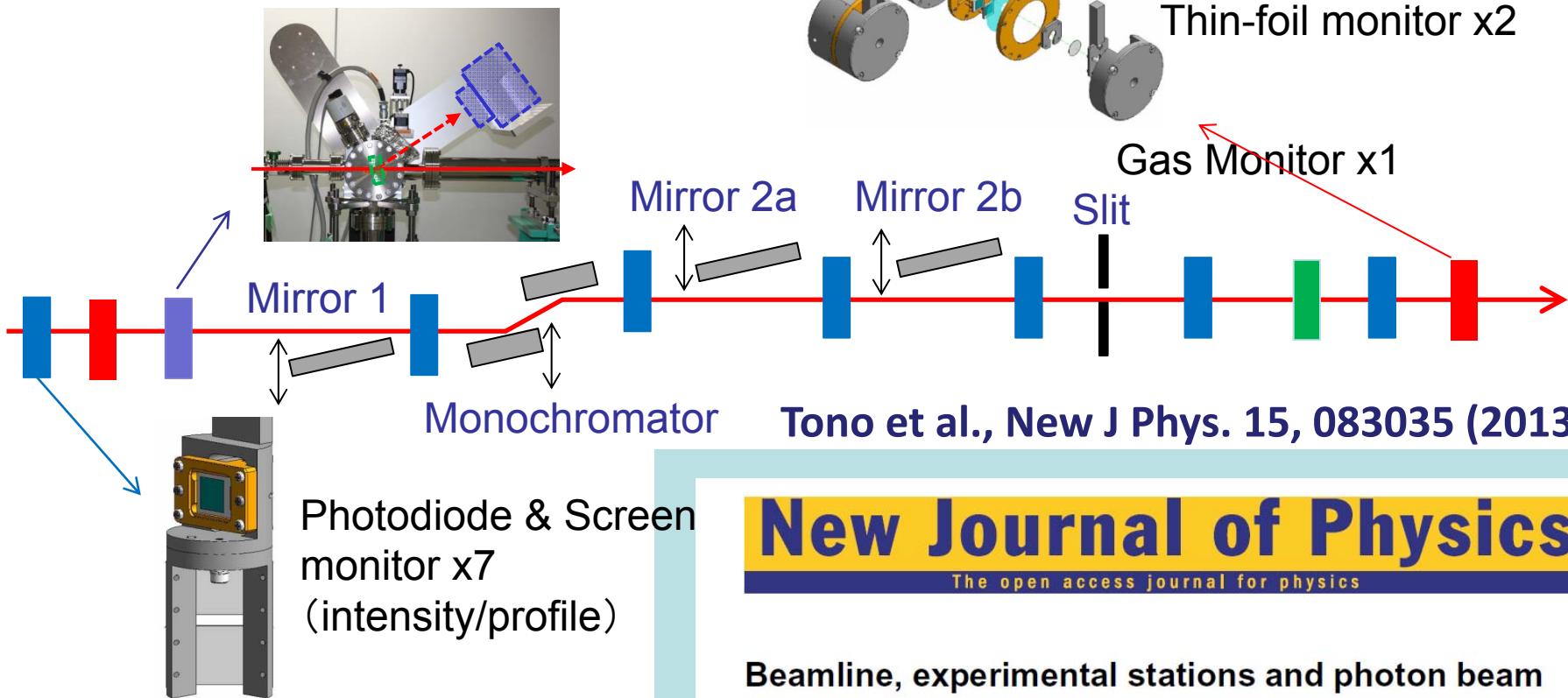
$\sim 10^{20} \text{ W/cm}^2$



Mimura et al, in preparation
X-ray energy: 10keV ²⁵

Beamline Optics & Diagnostics

In-line spectrometer x1



Tono et al., New J Phys. 15, 083035 (2013)

New Journal of Physics

The open access journal for physics

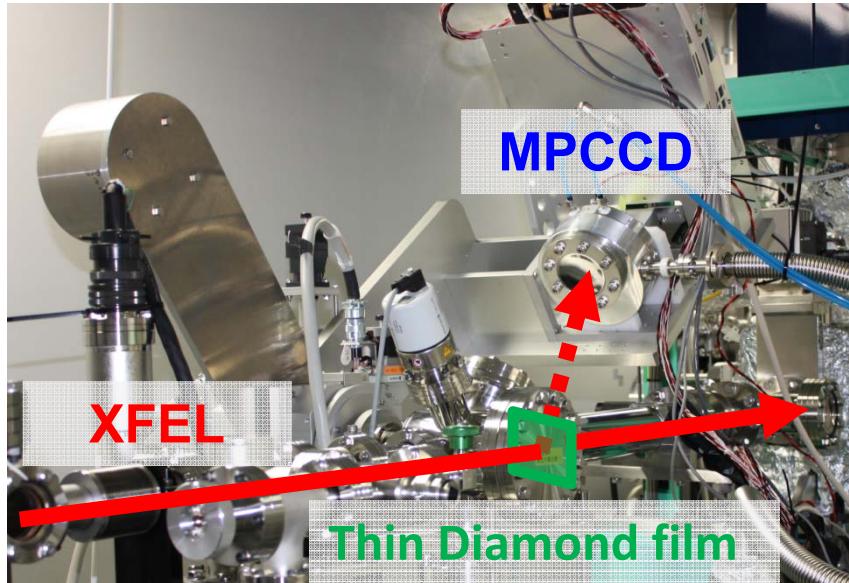
Beamline, experimental stations and photon beam diagnostics for the hard x-ray free electron laser of SACL

K Tono^{1,3}, T Togashi¹, Y Inubushi², T Sato², T Katayama¹,
K Ogawa², H Ohashi^{1,2}, H Kimura^{1,2}, S Takahashi^{1,2},
K Takeshita^{1,2}, H Tomizawa^{1,2}, S Goto^{1,2}, T Ishikawa²
and M Yabashi²

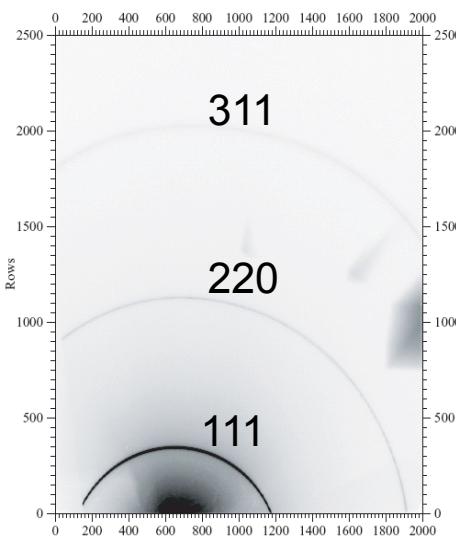
Contents

1. Introduction
2. Photon diagnostics (I): Intensity & transverse phase space
3. Photon diagnostics (II): Longitudinal phase space
4. Summary

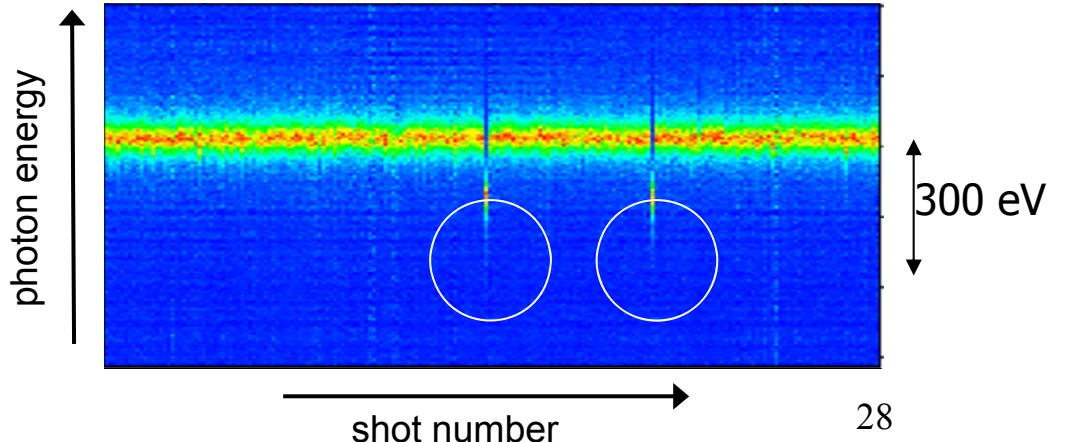
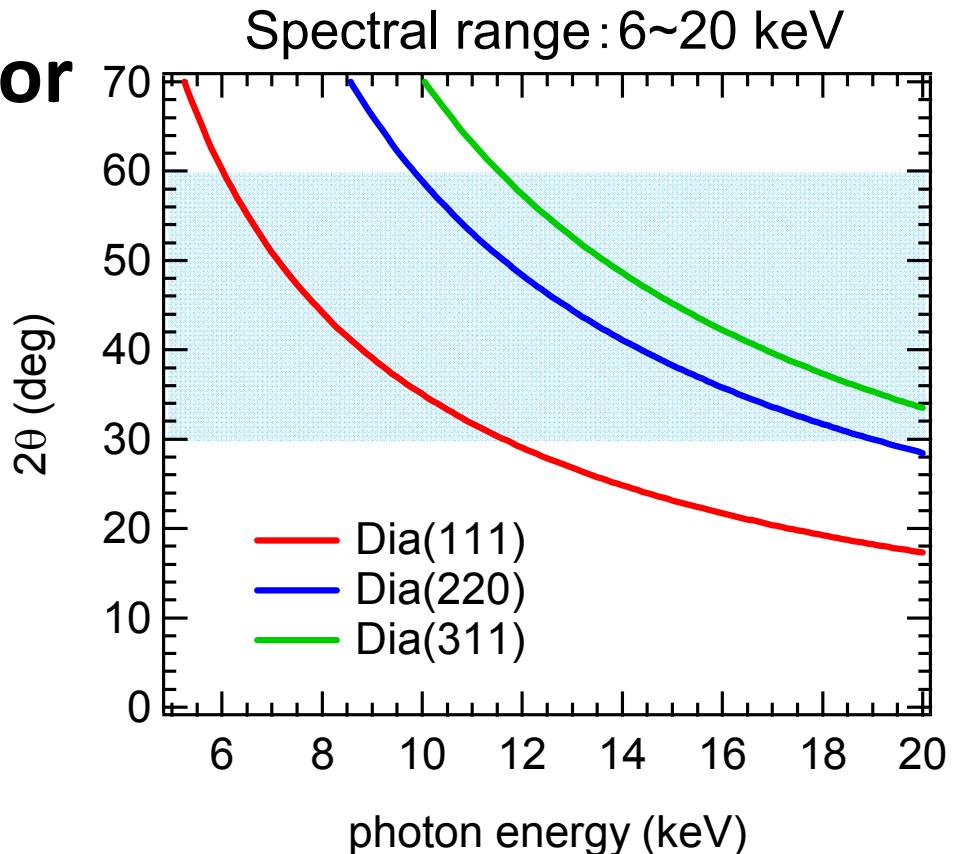
Central wavelength monitor



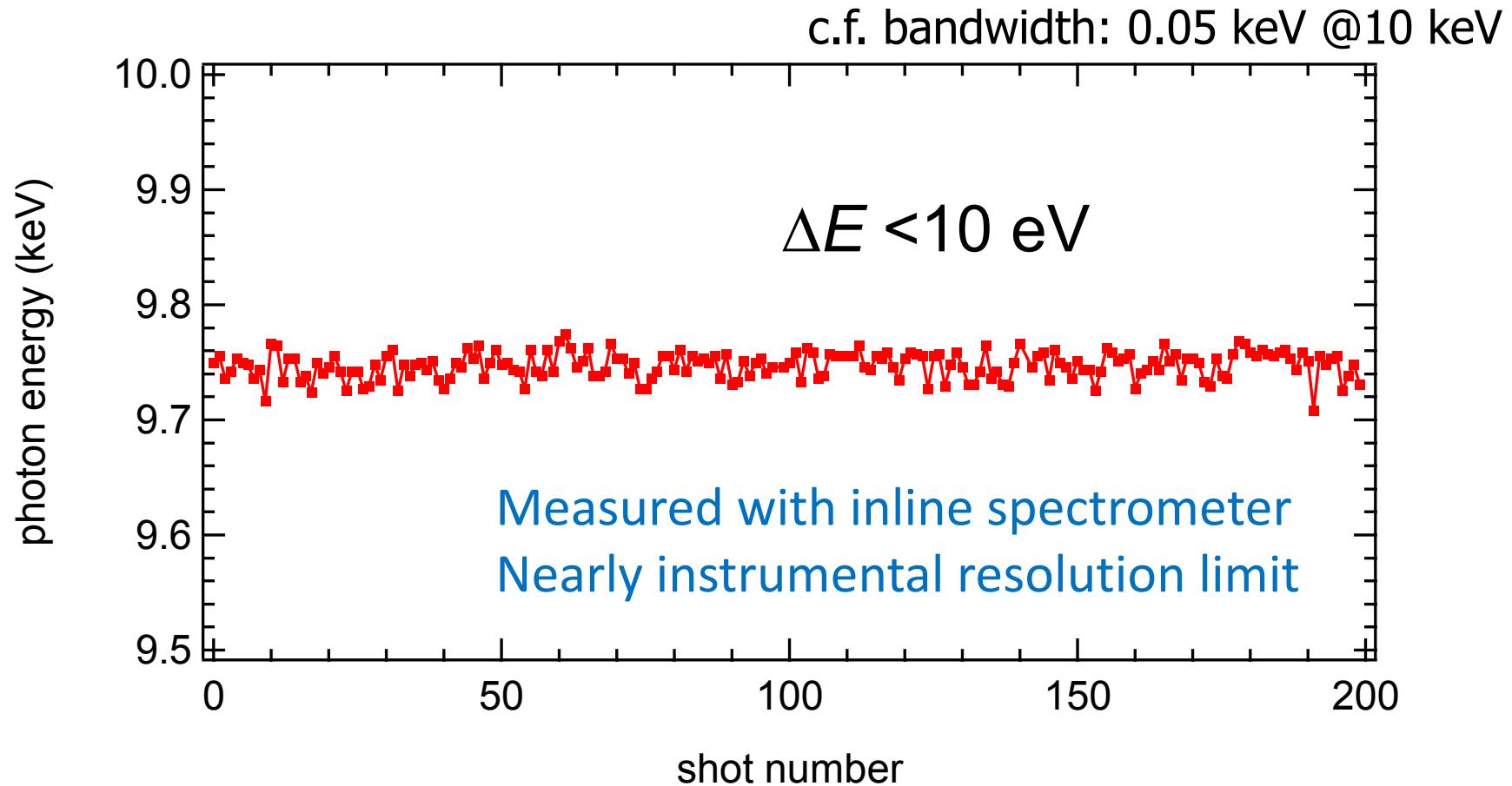
Inubushi-san



Diffraction ring from CVD diamond



High Wavelength Stability Routinely Achieved



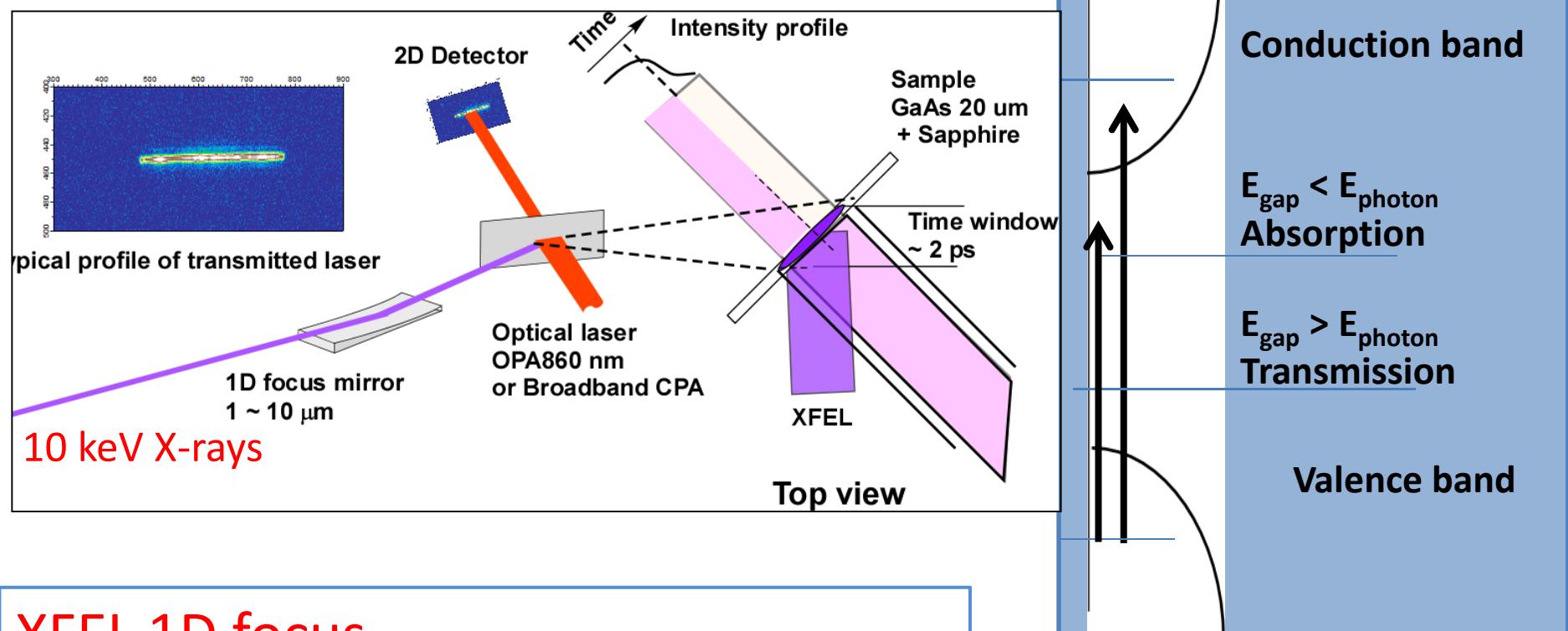
Arrival Timing

Harmand et al, Nat. Photon 2013



Transient transmission of optical laser induced with X-rays; **Spatial decoding**

Sato-san (SACLA/U Tokyo)
Ogawa-san, Togashi-san (SACLA)

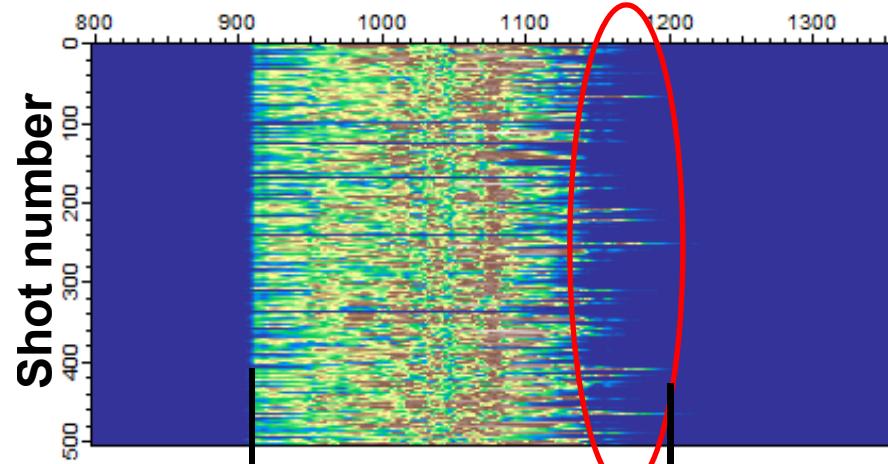


XFEL 1D focus

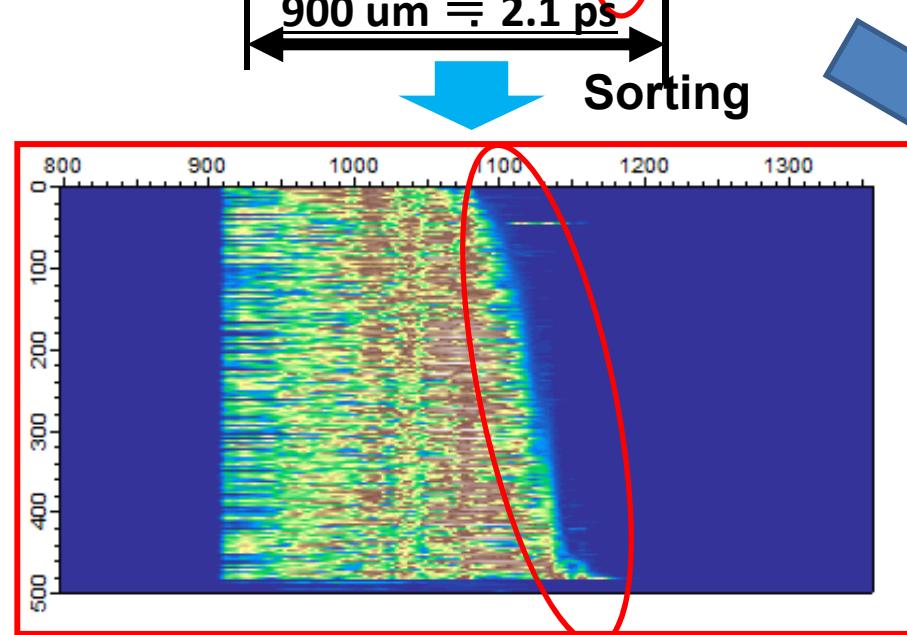
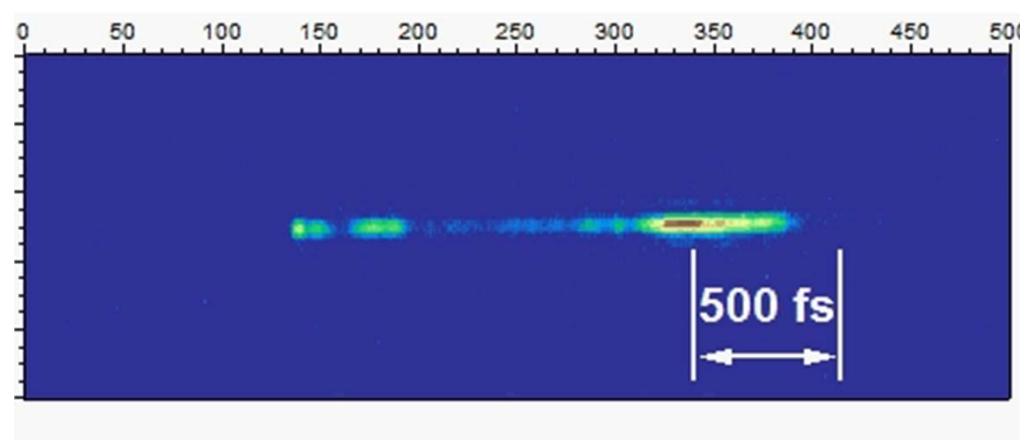
→ Pulse energy < 10 uJ

Jitters and Resolution

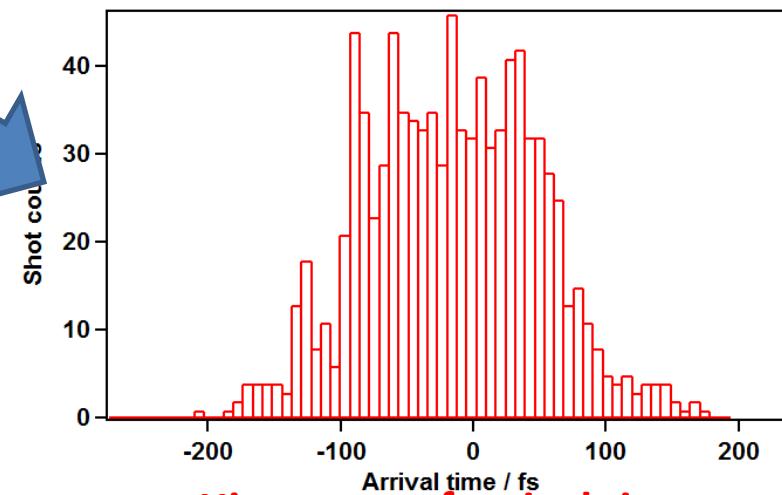
Sato et al., in preparation



Single shot image



~ 10 fs resolution

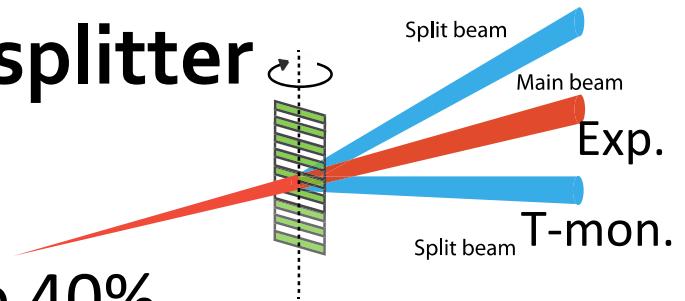


Histogram of arrival time
Timing jitter: 130 fs (rms)

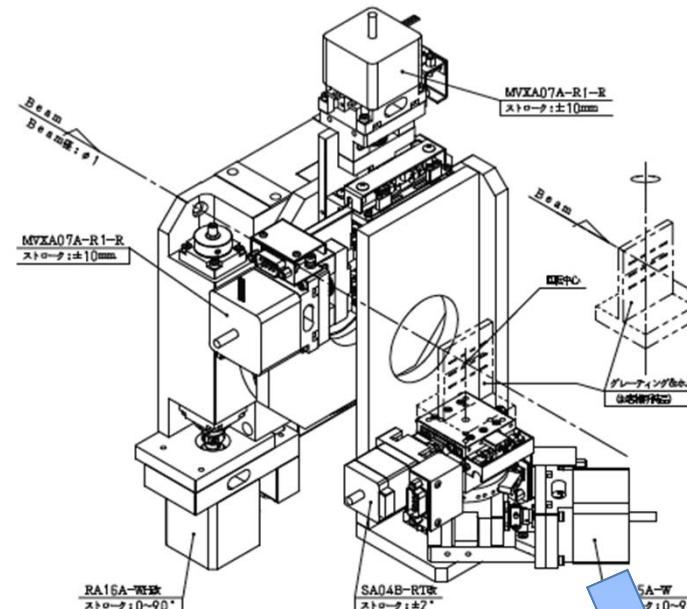
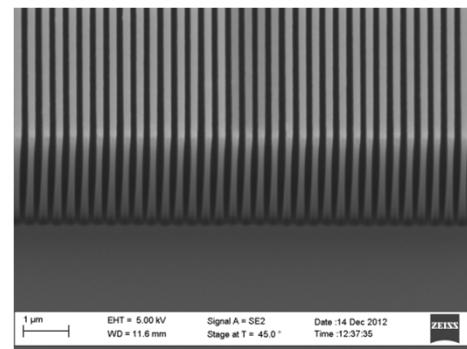
“From destructive to nondestructive”

Branching with beam splitter

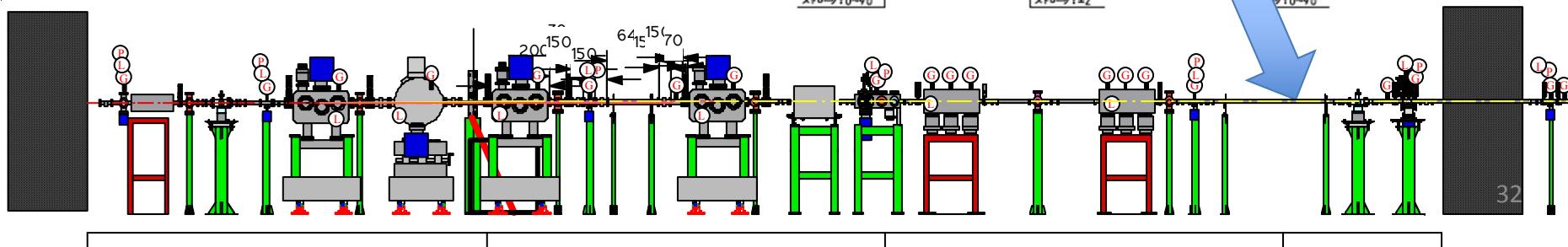
- Transmission grating
- Efficiency can be tuned from 0.1% to 40%
- Install to optics hutch as a permanent component



Si grating 300 nm p/1 um t



Collaboration with Ch. David (PSI)

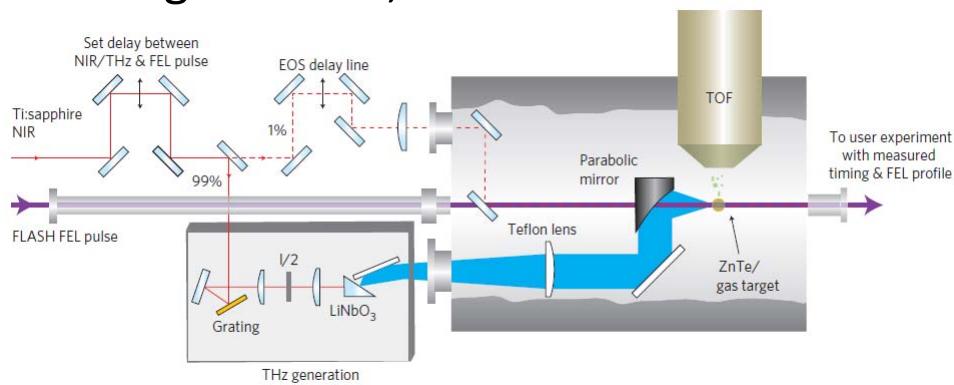


Summary of Performance

Pulse Energy	0.4 mJ @10 keV
Photon energy range	4.5 to 15 keV
Stability Intensity $\sigma_{\delta I/I}$	$\leq 10\%$
Pointing	3 ~7% of beam size
Repetition rate	20 Hz (Max. 60 Hz)
Pulse duration	??
Peak Power	??

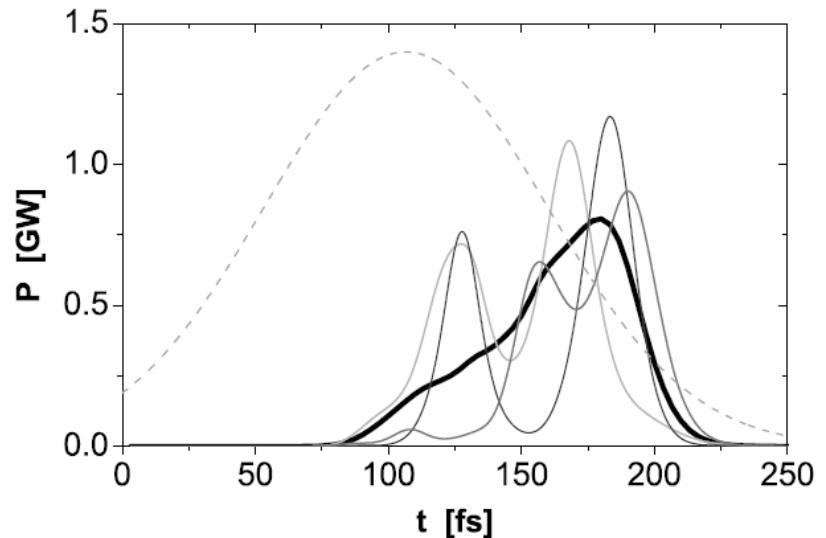
Temporal profile/Pulse duration

THz streaking method
Grguraš et al, Nat Photon. 2012

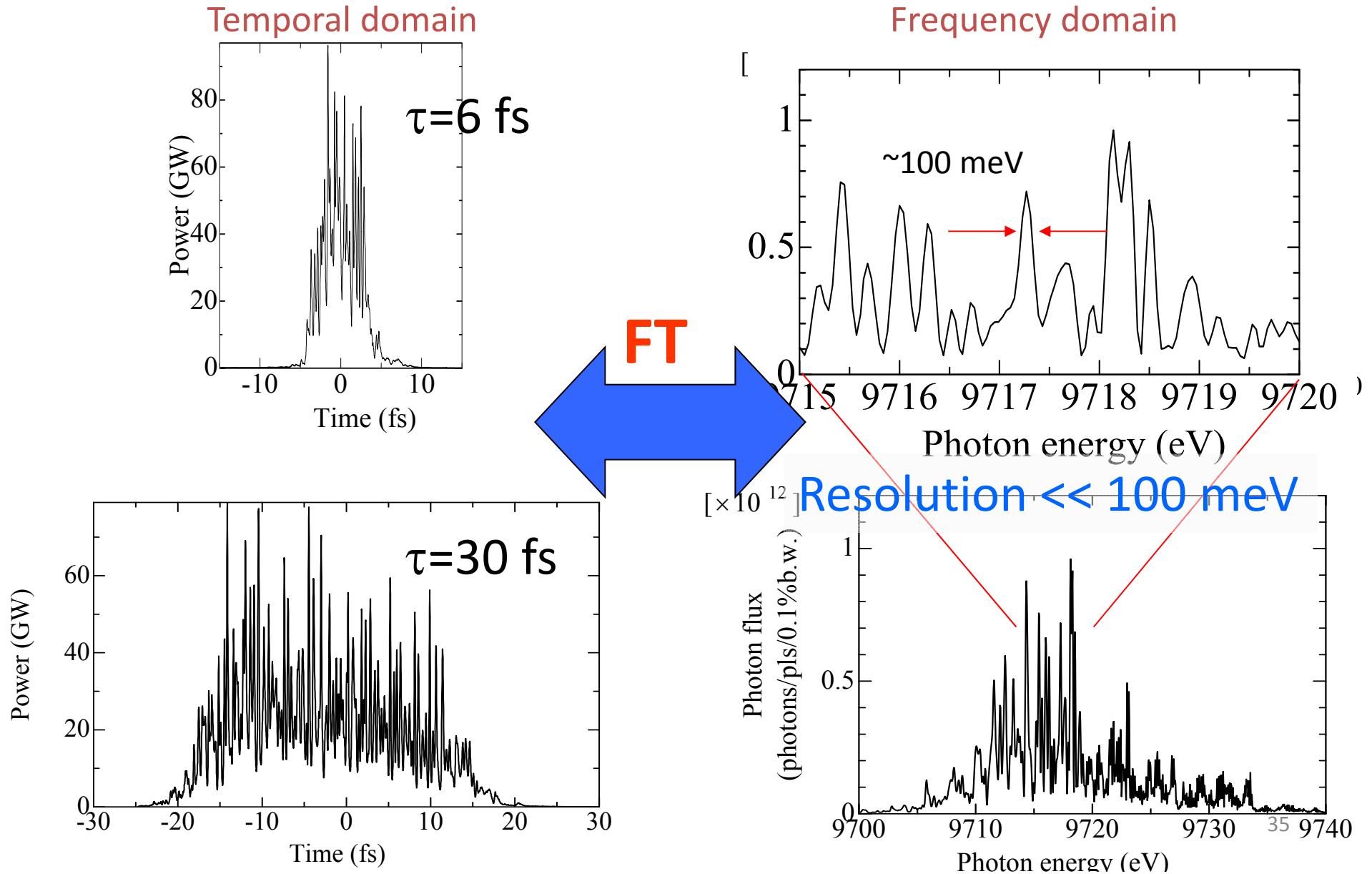


ref. T-CAV

Frequency domain
TTF-2 PRL (2002)
Shintake et al, Nat Photon (2008)

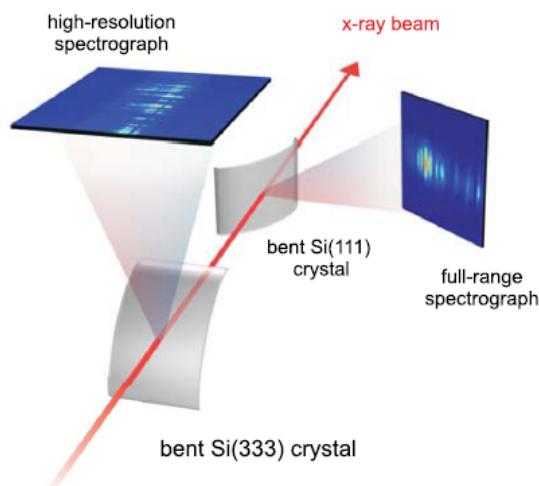


Temporal vs. Frequency



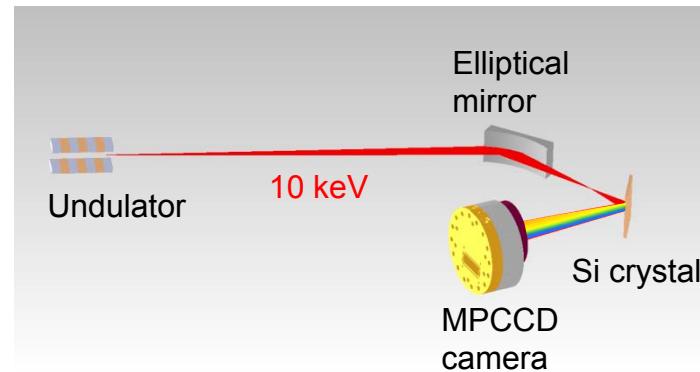
Recent developments of single-shot spectrometers

LCLS: Collimated beam + bent, thin crystal analyzer



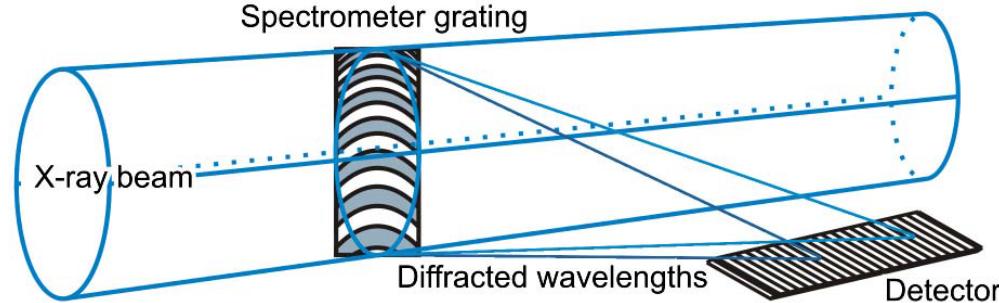
D. Zhu et al, APL **101**, 034103 (2012)

SACLA: Diverged beam (elliptical mirror) + flat, thick crystal analyzer



M. Yabashi et al, PRL **97**, 084802 (2006)
Y. Inubushi et al, PRL **109** 144801 (2012)

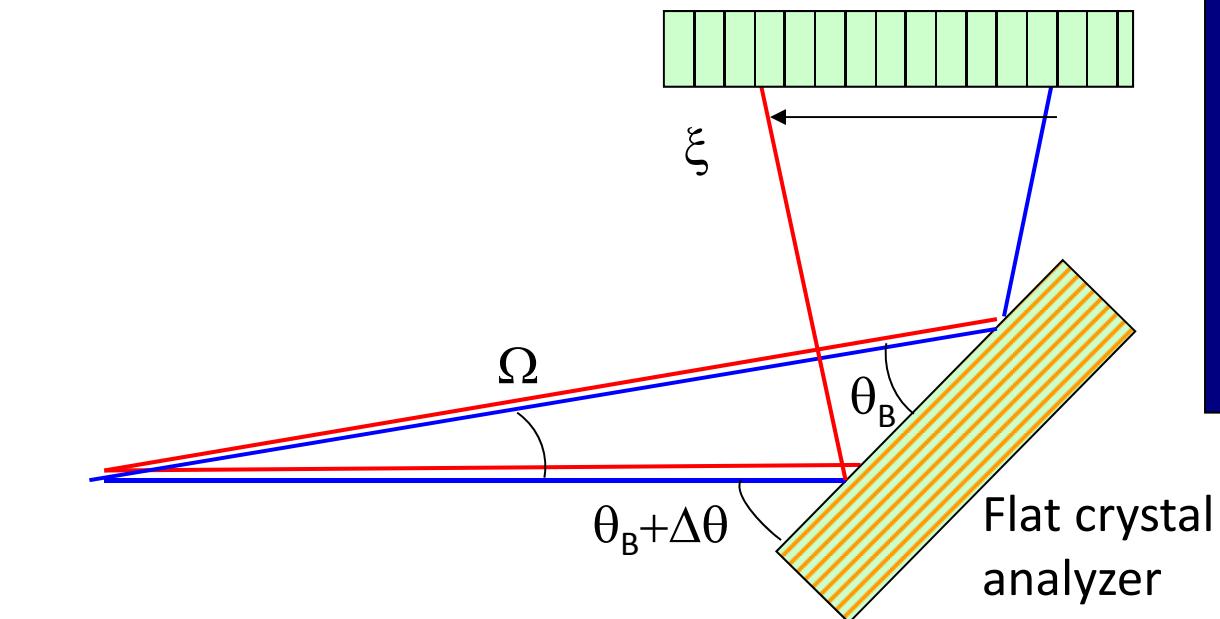
SwissFEL: Grating



P. Karvinen et al, Opt. Lett. **37** 5073 (2012)

Principle

Divergent beam
+ Flat Crystal Analyzer
+ Position Sensitive Detector

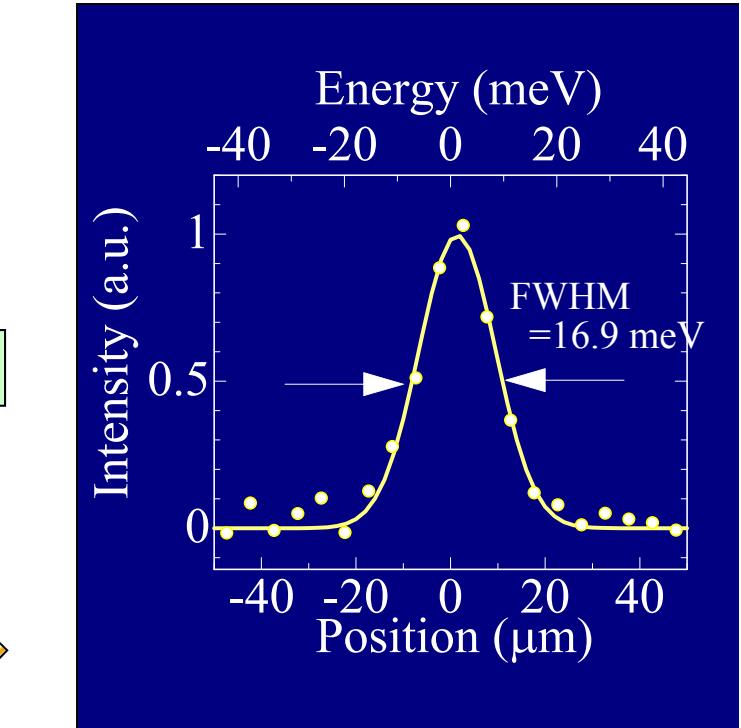


Resolution

$$\frac{\Delta E}{E} = \Delta\theta_{\min} \cot\theta_B$$

focus size extinction pixel size

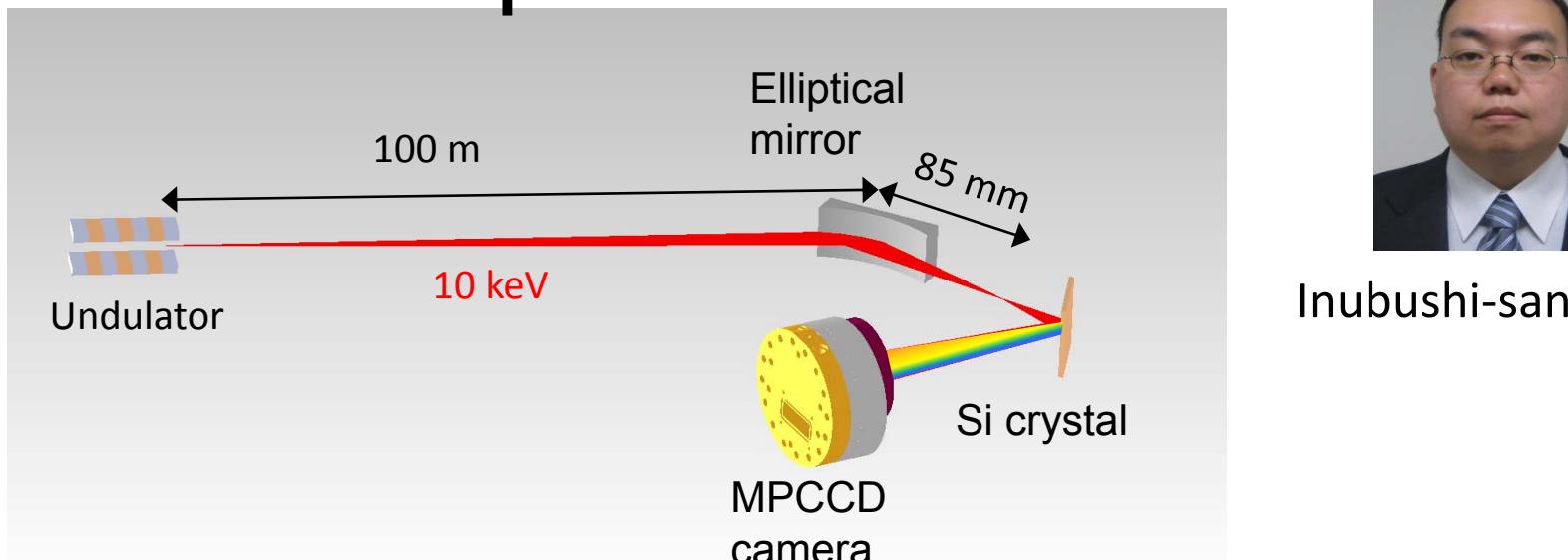
$$= \frac{\cot\theta_B \sqrt{\sigma_x^2 + (3.2\Lambda \cos\theta_B)^2 + s^2}}{L} \cong \omega_s \cot\theta_B = \frac{4r_e}{\pi v_c} |F_{hkl}| d_{hkl}^{3/2}$$



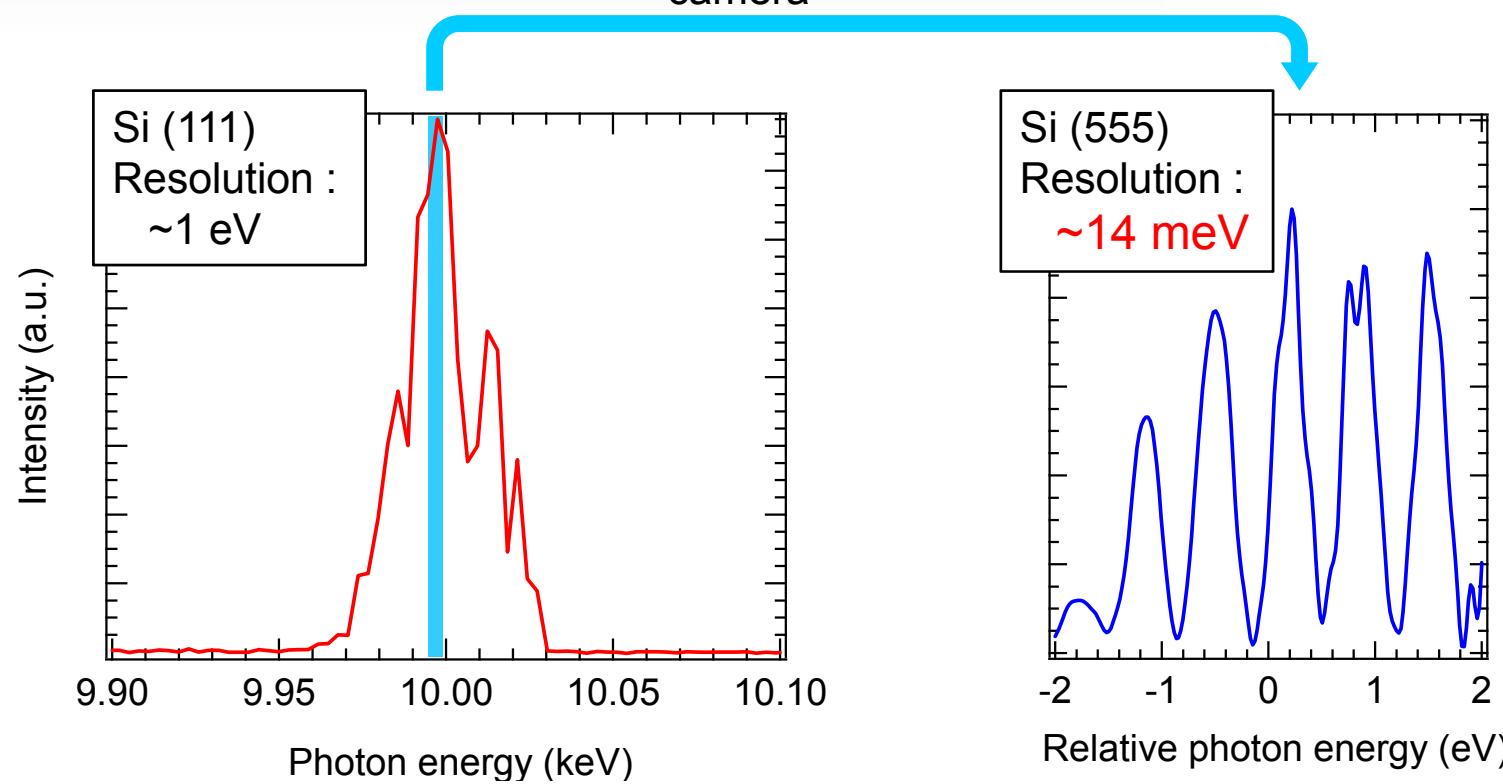
Measured at SPring-8
M. Yabashi et al, PRL
97, 084802 (2006)

Higher-order reflection ->
higher resolution

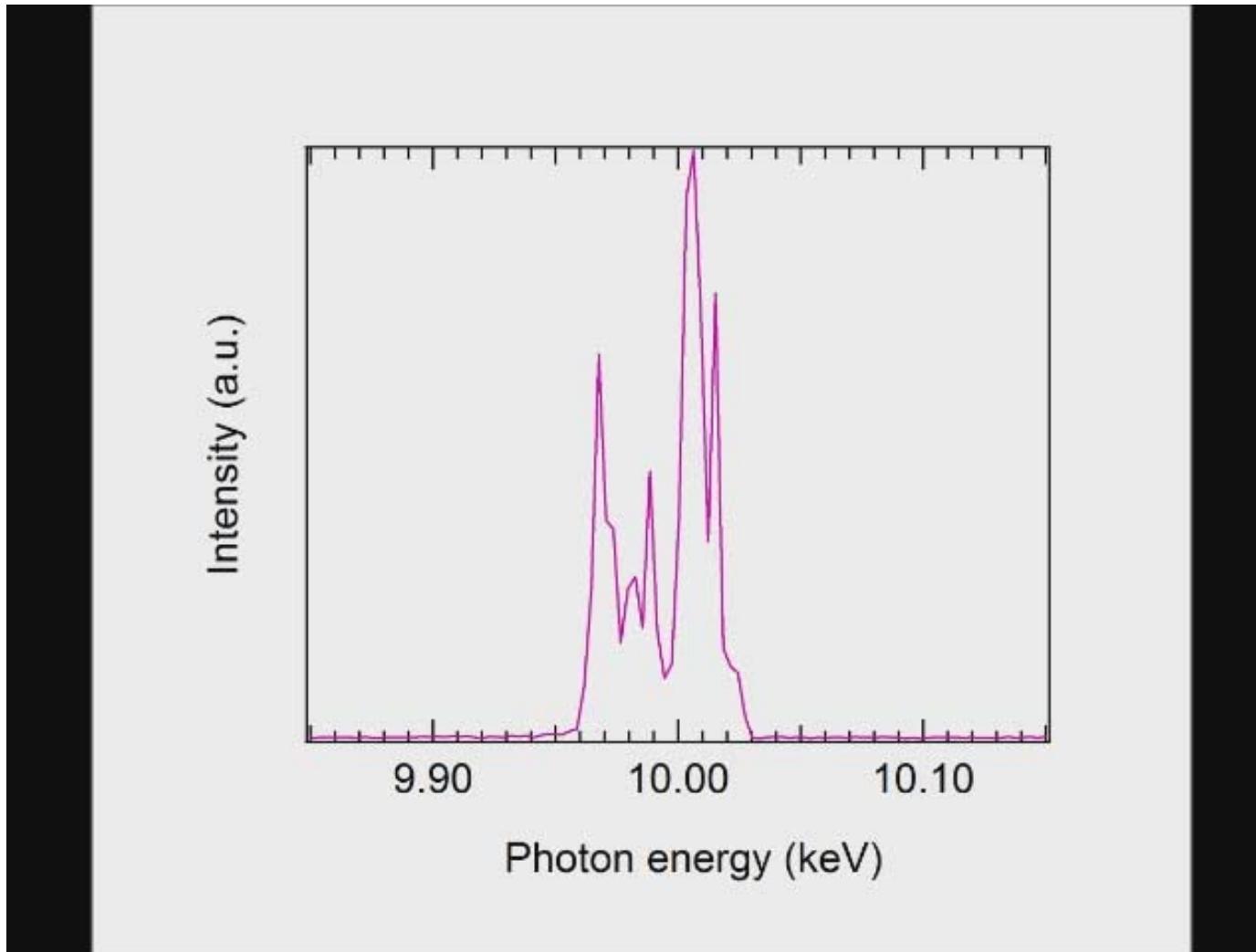
Development at SACL



Inubushi-san (SACL)

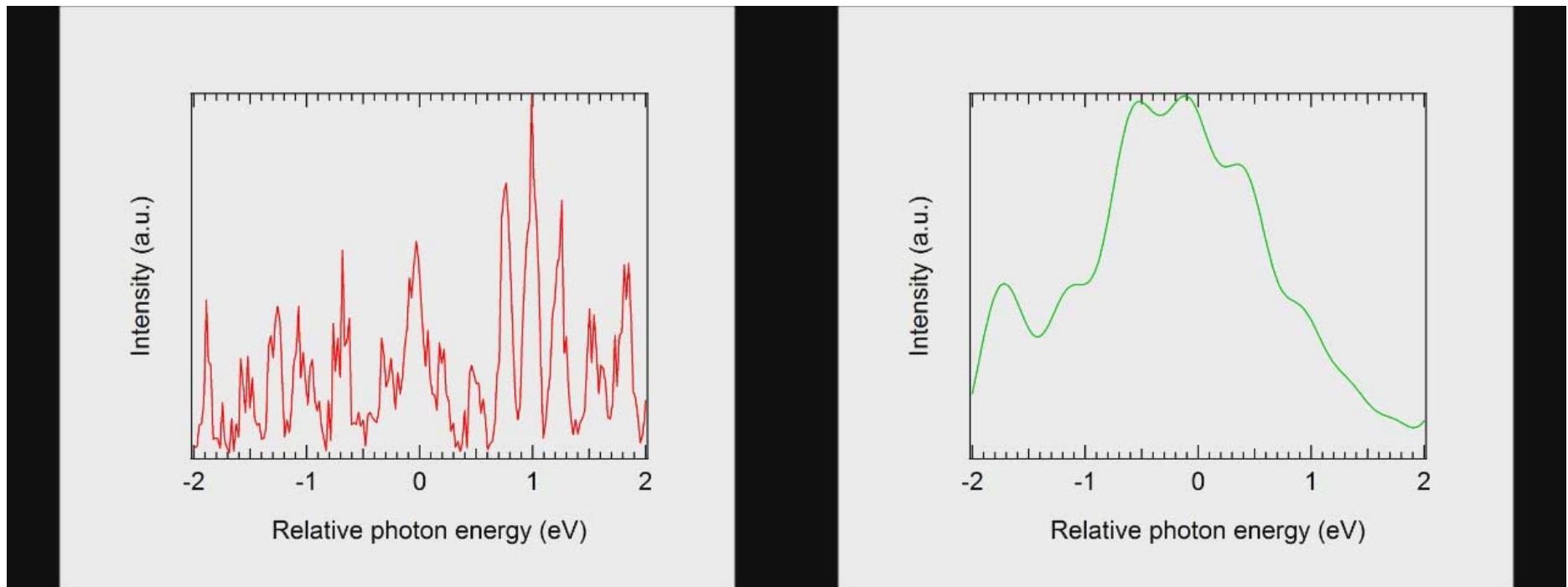


Single-shot spectra: wide range (~100 eV) with Si111

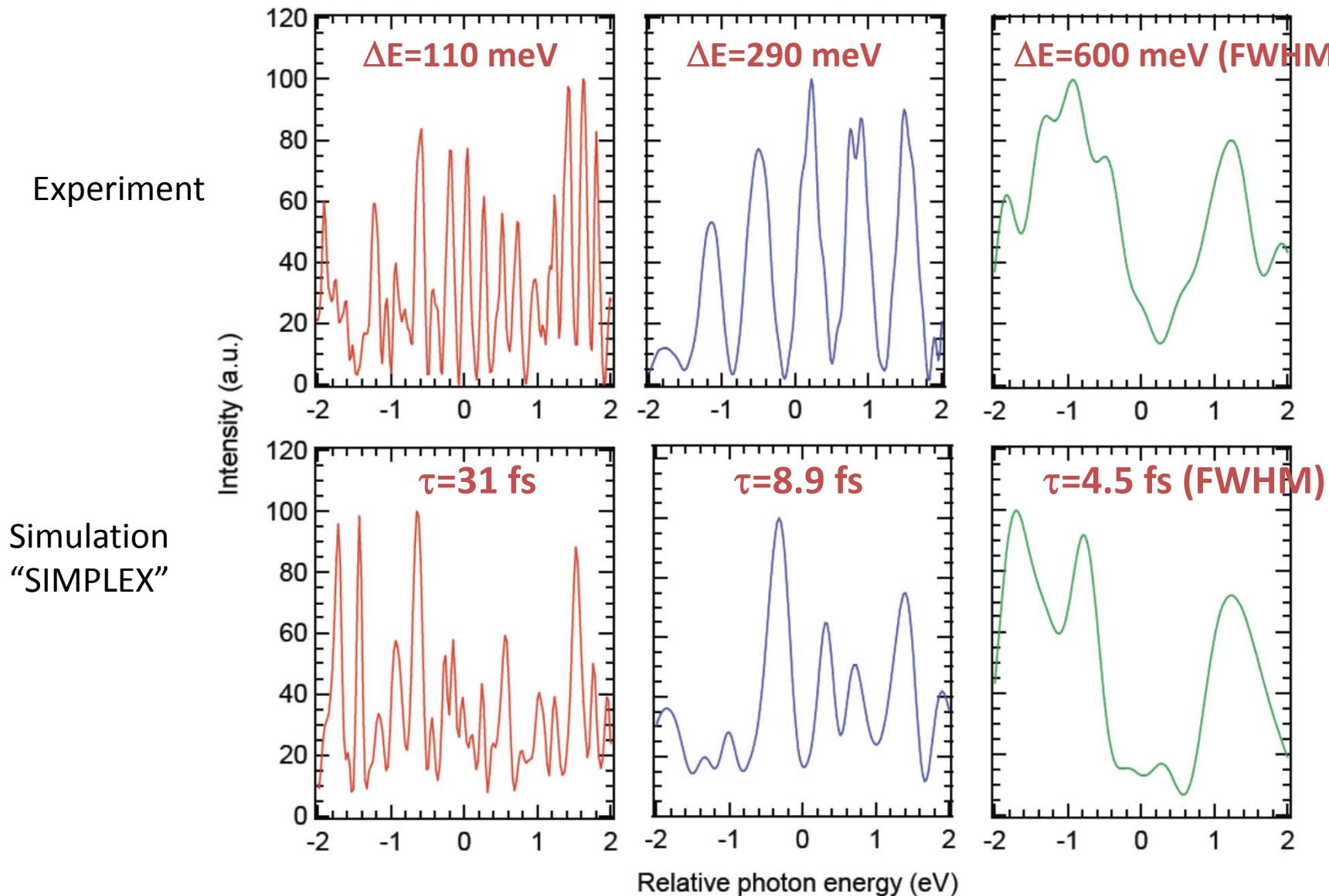


Spike profiles change in every shot due to SASE scheme
But central energy is stable

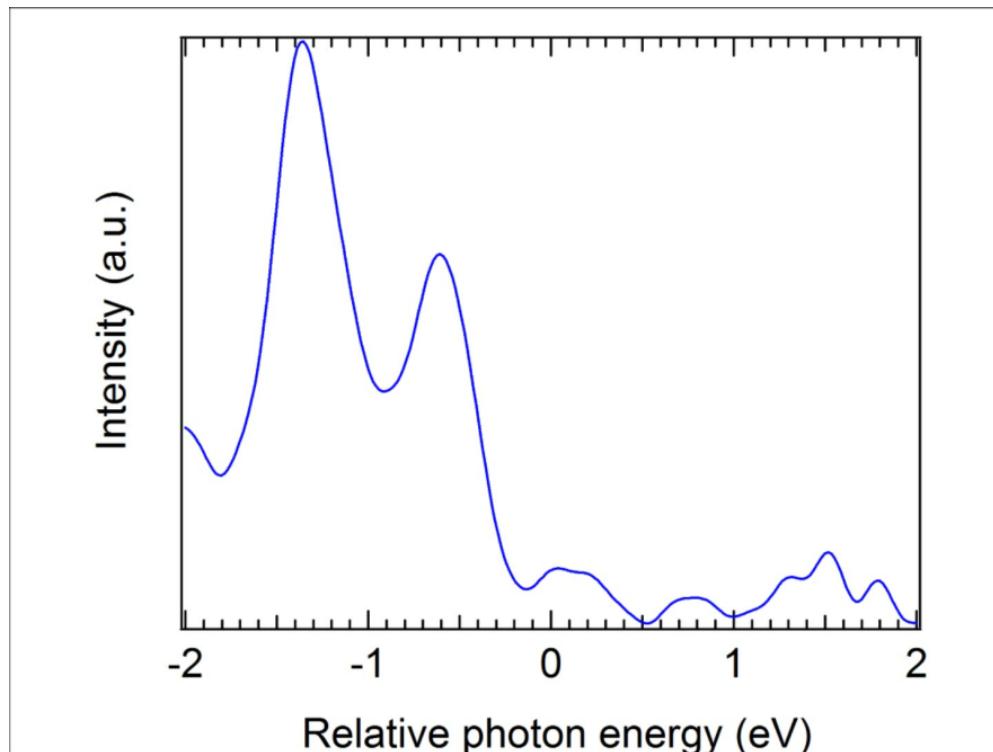
Single-shot spectra: high-resolution (14 meV) with Si 555



Evaluation of pulse duration using XFEL simulation



Recent operation condition (Jan 2013)



$$\Delta E = 400 \pm 60 \text{ meV} \quad \xrightarrow{\hspace{1cm}} \quad \tau \sim 6.5 \pm 1.5 \text{ fs}$$

$$300 \text{ uJ/pls (@ 10 keV)} \quad \xrightarrow{\hspace{1cm}} \quad 40 \text{ GW}$$

Summary of Performance

Pulse Energy	0.3 mJ @10 keV
Photon energy range	4.5 to 15 keV
Stability Intensity $\sigma_{\delta I/I}$	$\leq 10\%$
Pointing	3 ~7% of beam size
Repetition rate	10 Hz (Max. 60 Hz)
Pulse duration	< 10 fs
Peak Power	> 40 GW

Note: recent nonlinear X-ray experiment suggests shorter pulse duration (FWHM: 2.5-2.8 fs, Tamasaku et al, PRL 2013)

Continue to develop new methods

PRL 111, 043001 (2013)

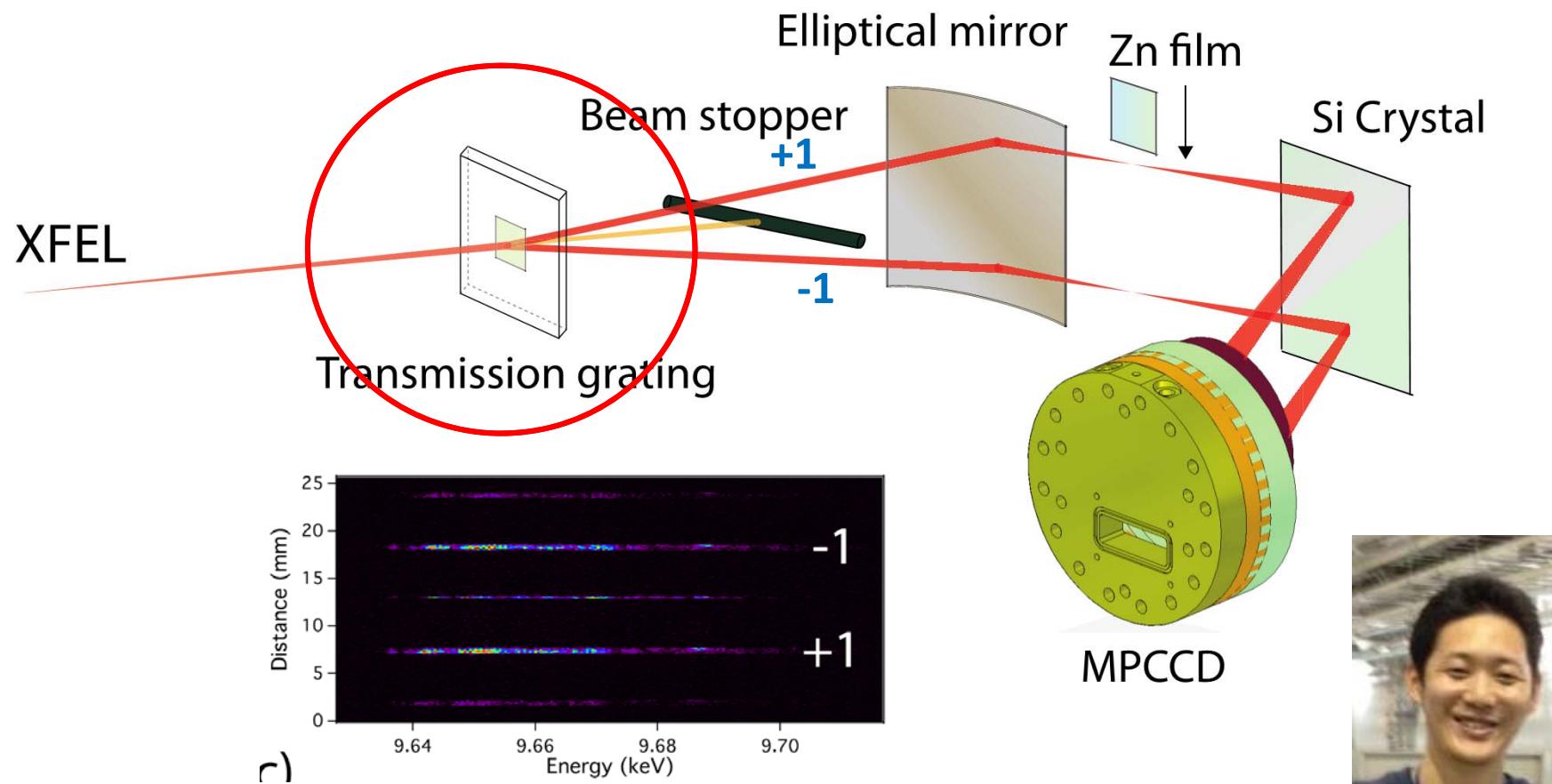
PHYSICAL REVIEW LETTERS

week ending
26 JULY 2013

Double Core-Hole Creation by Sequential Attosecond Photoionization

Kenji Tamasaku,^{1,*} Mitsuru Nagasono,^{1,†} Hiroshi Iwayama,² Eiji Shigemasa,² Yuichi Inubushi,¹ Takashi Tanaka,¹ Kensuke Tono,³ Tadashi Togashi,³ Takahiro Sato,¹ Tetsuo Katayama,³ Takashi Kameshima,³ Takaki Hatsui,¹ Makina Yabashi,¹ and Tetsuya Ishikawa¹

Application (II): Dispersive Absorption Spectroscopy

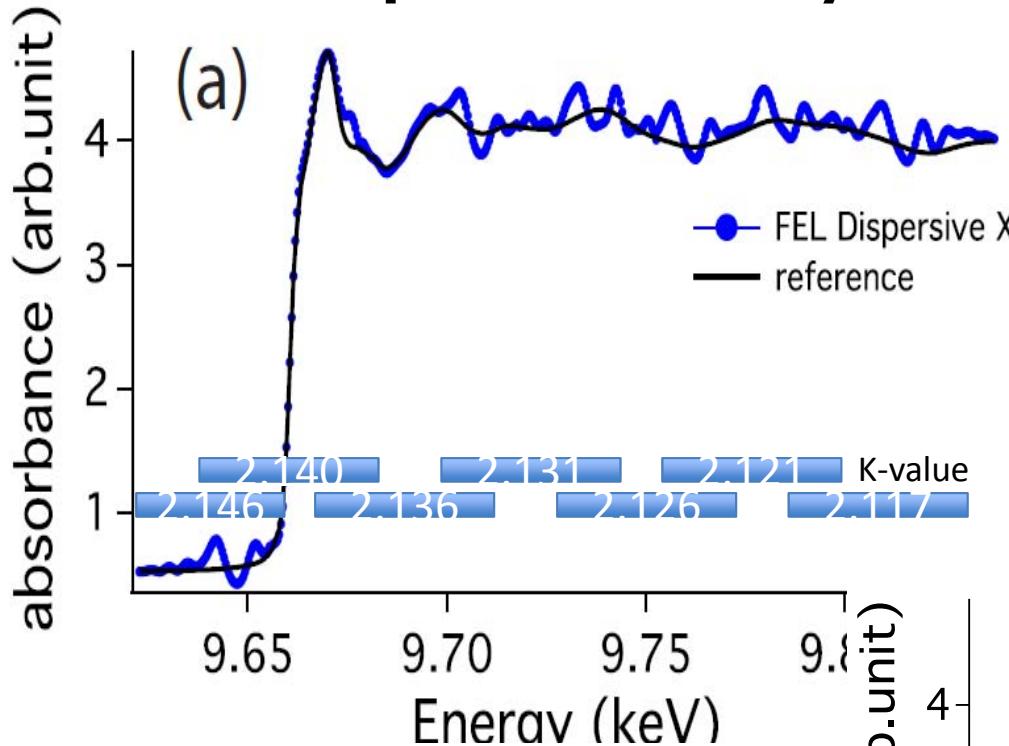


Normalization of SASE spikes by comparing
two spectra from +1 and -1 order

Katayama-san
(SACLA)

Collaborated with Profs. Toshinori Suzuki (Kyoto U), Kazuhiko Misawa (TUAT)
Kiyotaka Asakura (Hokkaido U)

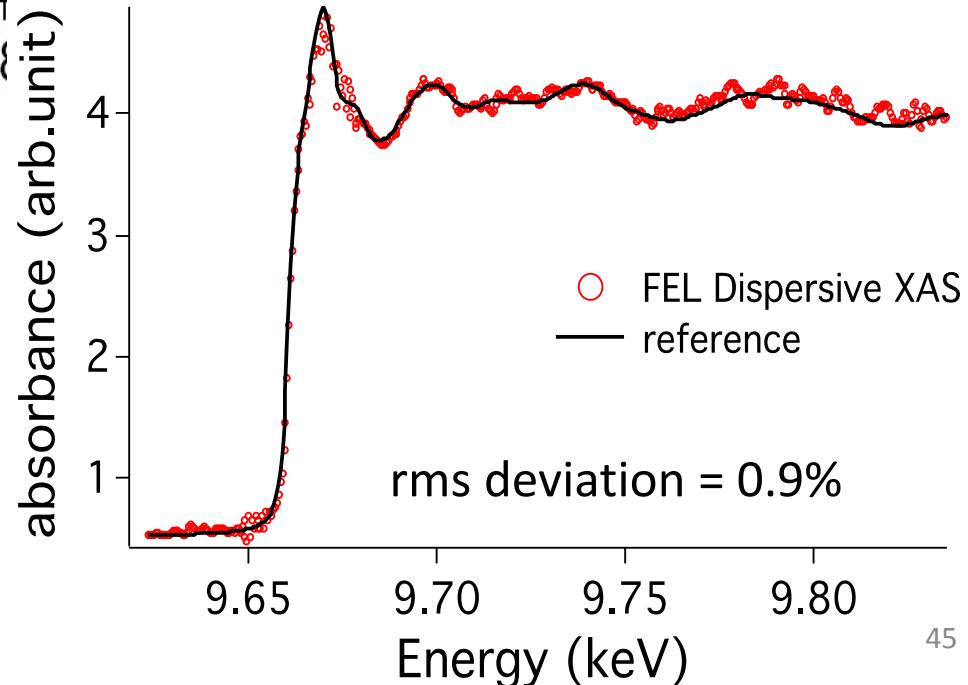
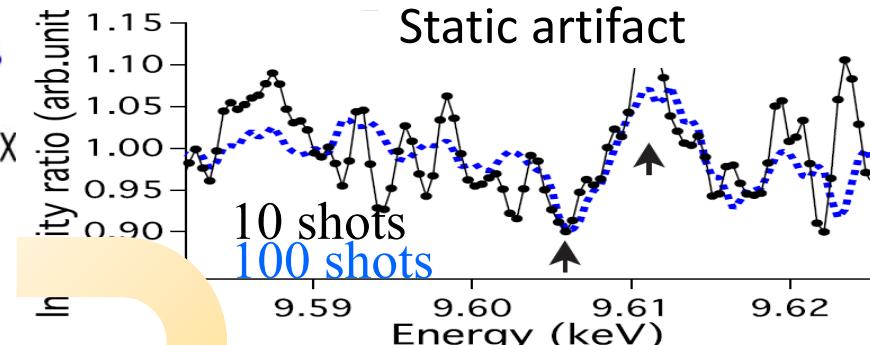
Dispersive X-ray absorption spectrum



- Zn thickness : 20 μ m
- 200 shots (one K value)
- Observable range 30 ~ 40 eV (one K value)
- resolution ~0.4 eV

200 shots (20 s) for measuring XAS with good S/N level

Katayama et al, APL, in press



Summary

- Photon diagnostics are practically working for **reliable and stable operation of XFEL machine**
- Advanced diagnostics promote to develop **user experimental methods**
- Close collaboration among **machine, beamline, and control-interface people** is essential
- Absolute pulse energy: easily measured with **RT calorimeter**
- Spatial profile: screen-based and edge-scan based methods are available, **single-shot high-resolution** method is demanded
- Wavefront: grating interferometer shows excellent performance
- Spectrum: high resolution below 20 meV with crystal spectrometer, useful for **seeded operation**
- Arrival timing: **below 10 fs** is possible
- Pulse duration: still need to develop, especially below 10-fs region
 - Spectral spikes, THz streaking, auto/cross correlation w XNL
- Still a lot of exciting challenges. Your valuable inputs, proposals, and collaboration are highly appreciated

Acknowledgement

All SACLAC/SPring-8 Members

Especially,

Kensuke Tono, Tadashi Togashi, Yuichi Inubushi, Tetsuo Katayama, Kanade Ogawa, Takaki Hatsui, Yasumasa Joti, Togo Kudo, Takashi Kameshima, Yoichi Kirihiara, Shun Ono, Hiroaki Kimura, Hiromitsu Tomizawa, Haruhiko Ohashi, Hirokatsu Yumoto, Takahisa Koyama, Shunji Goto, Kenji Tamasaku, Mitsuru Nagasono, Kazuaki Togawa, Takashi Tanaka, Toru Hara, Hitoshi Tanaka, Ryotaro Tanaka, Mitsuhiro Yamaga, Toru Ohata, Yukito Furukawa, Takashi Sugimoto, Hideo Kitamura, & Tetsuya Ishikawa

Yoshiro Fujiwara & Engineering Team

Osaka University

Yasuhisa Sano, Satoshi Matsuyama, Taito Osaka,

Univ. of Tokyo

Hidekazu Mimura, Takahiro Sato, Ichiro Inoue

Thank you for your attention

END